DebriSat Laboratory Analyses

January 5, 2015

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Abstract

The DebriSat test was conducted to better understand the distribution of fragments generated from a hypervelocity impact with a modern satellite. The last such test (SOCIT) was conducted 20 years ago and satellite construction has changed considerably since then. DebriSat was a NASA program with support/collaboration from the Air Force Space and Missile Center, University of Florida and Aerospace. Tests were conducted at the Arnold Engineering Development Complex Range G Two-Stage Light Gas Gun Facility. The 50 kg target was a constructed by the University of Florida from materials representative of a modern LEO satellite. The Aerospace Concept Design Center advised on the selection of materials for various subsystems. The test chamber was lined with "soft catch" foam panels to trap fragments for size distribution analysis. A witness plate assembly was constructed by Aerospace in order to catch and sample debris and returned to Aerospace after the test for analysis. Aerospace also placed SEM stub witness plates into the soft catch panels for post test retrieval and analysis. The test was conducted with a pressure of 1-2 Torr of air and used a ~600 gram projectile with a nominal velocity of 7 km/s.

The SEM stubs, witness plate assembly and DebriSat fragments were covered with black soot and were contaminated with soft catch foam fragments. The SEM stubs were also covered with a thin film of condensed soft catch vapor, similar to that seen with the Debris-LV test which also used soft catch foam panels. Deposits on the SEM stubs and witness plate assembly are predominantly carbon and consist of agglomerates of nano carbonaceous material. These deposits are primarily from the soft catch (similar to Debris-LV) though the C-C composite honeycomb face sheets and MLI are also possible sources. Disordered graphitic carbon is present based on Raman spectra and TEM lattice fringe images. Graphitic carbon was also seen in Debris-LV deposits even though there were no carbon containing materials in the target. The witness plate assembly was covered in a black layer of loose "soot", even under the protective Whipple plates. Removal of the loose material by rinsing with isopropyl alcohol revealed a thin adherent coating on one side_of the support posts indicating early directional deposition from DebriSat. The coating was carbonaceous (disordered graphite) with nano metal droplets. Fluorine from Teflon wire insulation was also common in the SEM stub and witness plates deposits. Nano droplets of metallic materials (Al, Fe, Cu, Zn, Ge) were also present indicating melting as a result of the impact. Solidified molten metal droplets were also seen in Pre Preshot and Debris-LV debris. Aluminum was from the Al honeycomb, nadir and zenith panels, structural core and COPV liner. Aluminum oxide particles were also present. Iron was from stainless steel tubing and solenoids. Germanium was from the solar cells and copper was from wiring and solenoids. The source of the zinc has not been identified. The solidified molten nano metal droplets are crystalline based on TEM lattice fringes and consist of only a few crystallites.

The witness plates show a significant decrease in reflectance (95% to 6%). Soft catch contamination was seen in the LWIR reflectance spectra of DebriSat fragments, SEM stubs and witness plate. As a result, it was not possible to get a clean spectrum of the debris generated by the hypervelocity impact. An additional "oxide" band, which may be from a form of aluminum oxide, was seen on some samples.

Acknowledgements

DebriSat Team Members:

J.-C. Liou: NASA Space Debris Program Office, NASA JSC

AEDC Range G Light Gas Gun Staff

Charles Griffice: Aerospace Marlon Sorge: Aerospace Patti Sheaffer: Aerospace

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Patti Sheaffer Charles Griffice

UV-VIS-NIR Spectroscopy Dianna Alaan



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5 January, 2015

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Physical Sciences Laboratories

Introduction

- The DebriSat test was conducted to better understand the distribution of fragments generated from a hypervelocity impact with a modern satellite.
 - The last such test (SOCIT) was conducted 20 years ago and satellite construction has changed considerably since then.
 - In 2009 a Cosmos 2251 upper stage collided with an Iridium 33 satellite.
 - Produced 2000+ trackable fragments (>10 cm).
 - 8 other known collisions, some only known long after occurrence.
- DebriSat was a NASA program with support/collaboration from the Air Force Space and Missile Center, University of Florida and Aerospace.
- Tests were conducted at the Arnold Engineering Development Complex, Tullahoma, Tennessee.
 - Two-Stage Light Gas Gun Facility Range G.
 - Largest such facility in the United States.
 - All tests used a ~600 gram projectile with a nominal velocity of 7 km/s.



Introduction (cont.)

- Two trial tests were conducted prior to DebriSat.
 - Pre Preshot. February 2014
 - Debris-LV (Pre Shot). 1 April 2014
- Debris-Sat was conducted 15 April 2014
 - The 50 kg target was constructed by the University of Florida from materials representative of a modern LEO satellite.
 - Aerospace Concept Design Center advised on selection of materials for various subsystems.
 - Test chamber was lined with "soft catch" foam panels to trap fragments for size distribution analysis.
 - A witness plate assembly was constructed by Aerospace in order to catch and sample debris and returned to Aerospace after the test for analysis.
 - Aerospace also placed SEM stub witness plates into soft catch for post test retrieval and analysis.
 - Test conducted with a pressure of 1-2 Torr of air.



Introduction (cont.)

- Documentation to date.
 - Aerospace TOR-2014-03201, Time-resolved Spectroscopy of Hypervelocity Impact Flash on DebriSat, Gouri Radhakrishnan.
 - Aerospace ATM-2014-03659, DebriSat Hypervelocity Impact Fragmentation Modeling, Naoki Hemmi.



Background

- "Darkening" of satellites has been observed as a result of suspected hypervelocity impacts.
- The material and processes responsible for the darkening is unknown.

Objectives

- Materials collected on witness plates in the DebriSat test were analyzed in order to identify the source and conditions responsible for the darkening.
- UV-VIS-NIR-LWIR reflectance spectra were measured of post test debris for comparison with pre test sources to determine the spectral signature of material generated by a hypervelocity impact.
- Possibly determine if a hypervelocity impact occurred based on remotely sensed spectra?
 - Can the source be identified does it have a unique signature?

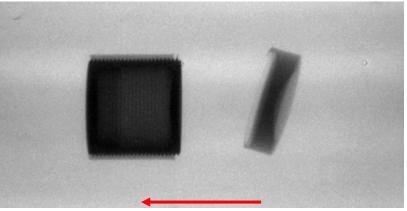


Projectile

Images by AEDC







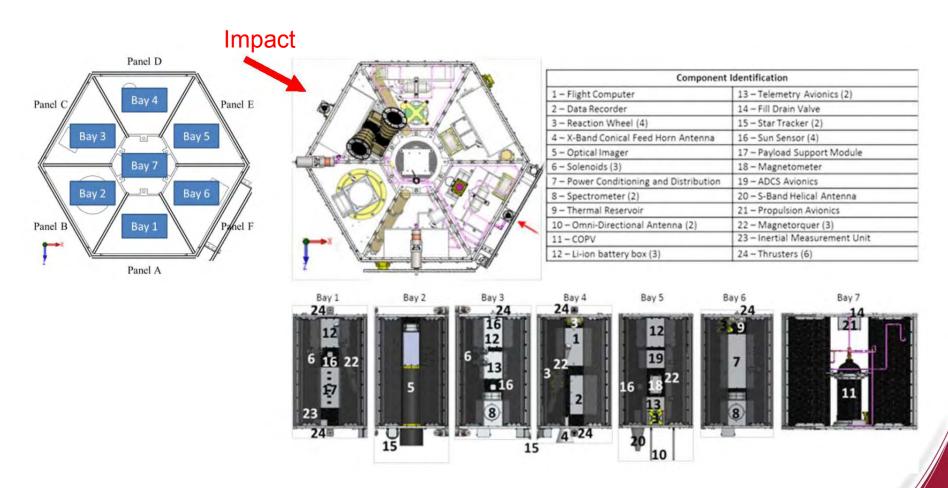
Flash X-ray of projectile in flight

- Constructed from three pieces: Outer Nylon shell (sabot) with 2 part hollow aluminum insert.
- ~600 grams, 8.6 cm diameter X 10.3 cm long size of a soup can.
- Velocity ~ 6.8-6.9 km/s.
- The Nylon base separated from the Nylon-aluminum body during flight.



SBU Marking

DebriSat Construction



Projectile impacted normal to Bay 3

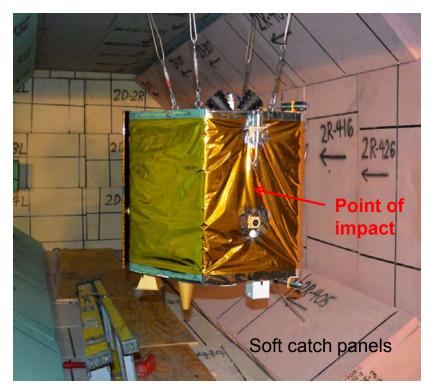


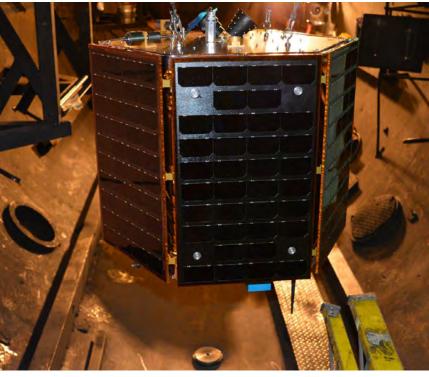
Materials Present on DebriSat

- Nadir and zenith panels: Aluminum 6061
- Face panels and structural ribs: Aluminum 5052 honeycomb with carbon fiber/epoxy face sheets
- COPV tank pressurized to 2 torr with air
- Optics : SiO₂, sapphire
- Solenoids : Cu
- Stainless Steel (316, 304): Fe, Cr, Ni
- Printed circuit boards (electronics hardware)
- Li-ion batteries: Cu-polyimide (no Li or electrolyte)
- Solar cells: Ge substrate with GaAs/InP/GaInP
- Kevlar, polyurethane, Mylar, Kapton



Installed in Chamber: Pre test





Looking down range.

DebriSat is covered with multi layer insulation (MLI).

Looking up range. Solar panels - undeployed



Nadir / Under Side

S-band cone antenna

X-band — horn antenna

Spectrometer Baffle (Bay 6)

Spectrometer Baffle (Bay 3)

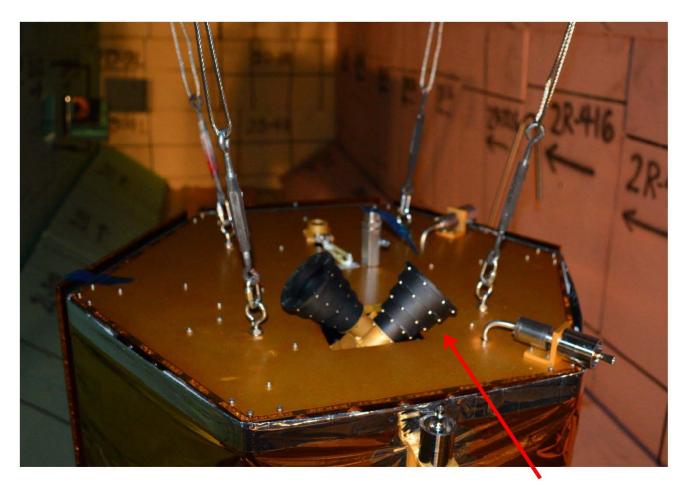
Optical imager sun shade

Adapter plate

Aluminum components had various types of anodized finishes (clear, black, blue, gold) to aid in post test fragment identification.



SBU Marking Zenith / Top Side



Star trackers



Witness Plate: Pre Test

Whipple Plates



Witness Plate Samples:

Direct Exposure

- (4) 1" fused silica
- (1) 1" Z-93 painted Al
- (1) 1" Aluminum

Multi layer insulation (not shown)

Protected Under Whipple Plates

- (2) 1" fused silica
- (1) 1" Z-93 painted Al
- (1) 1" Aluminum
- (1) 1" NaCl
- (1) Cu sheet

Ge ATR crystal (for FTIR)

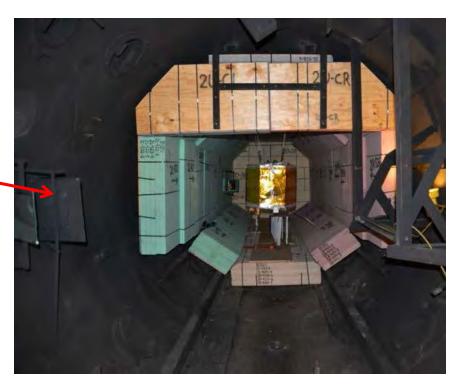
Solar cell

Witness plates located in same position in chamber as Debris-LV. ~3 meters up range of DebriSat.



Witness Plates Mounted in Chamber

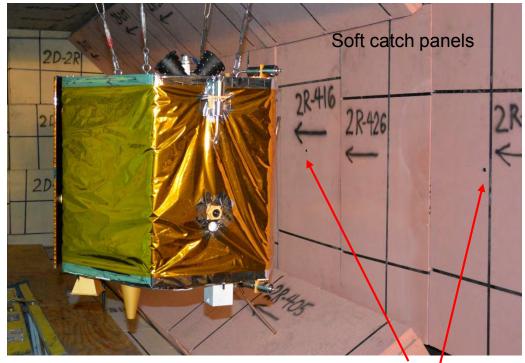




Plates mounted about 3 meters up range of DebriSat

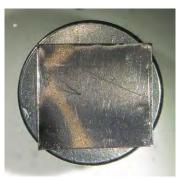


SEM Stub Witness Plates Placed into Soft Catch Panels



12.5 mm Al SEM stubs





with Ta sheet

SEM stubs

- •24 Aluminum SEM stub witness plates (12.5 mm dia) placed in soft catch with RTV adhesive.
- •Tantalum sheet (9 mm x 9 mm) epoxied to front surface in order to distinguish Al debris from stub.
- •Identified on back with engraved numeral.
- •11 stubs recovered (+); 5 with Ta sheet present (++), 6 in place (*)
- •Remaining stubs embedded in soft catch. to be recovered at U. of F.



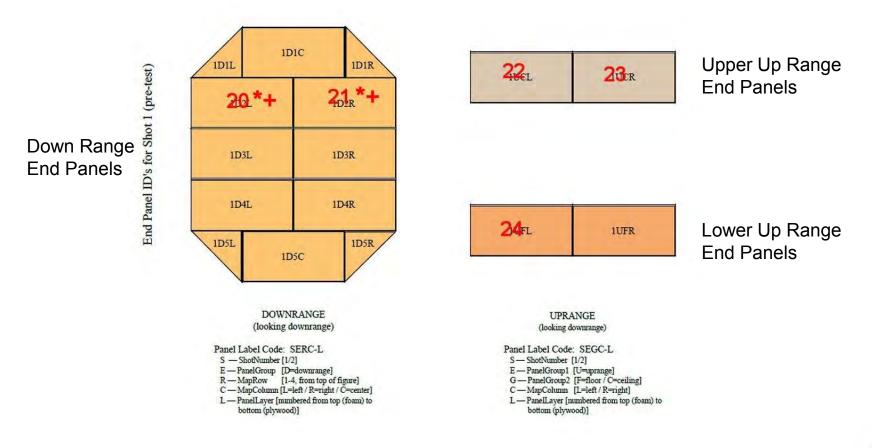
SBU Marking Location of SEM Stubs (red) on Soft Catch Panels



Nominal location of DebriSat is above 2F-424 and 2F-514
stubs recovered (+), with Ta sheet present (++), in place (*)
Intact recovered stubs with Ta (*++) tended to be furthest from impact site



Location of SEM Stubs (red) on Soft Catch Panels



•stubs recovered (+), with Ta sheet present (++), in place (*)

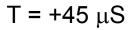


DebriSat Impact: Frames from High Speed Video

 $T \sim 0 \mu S$ $T = -180 \mu S$ Projectile



DebriSat Impact: Frames from High Speed Video



$$T = +270 \mu S$$







Laboratory Results

(Supplemental Information and Additional Analyses in Appendix)

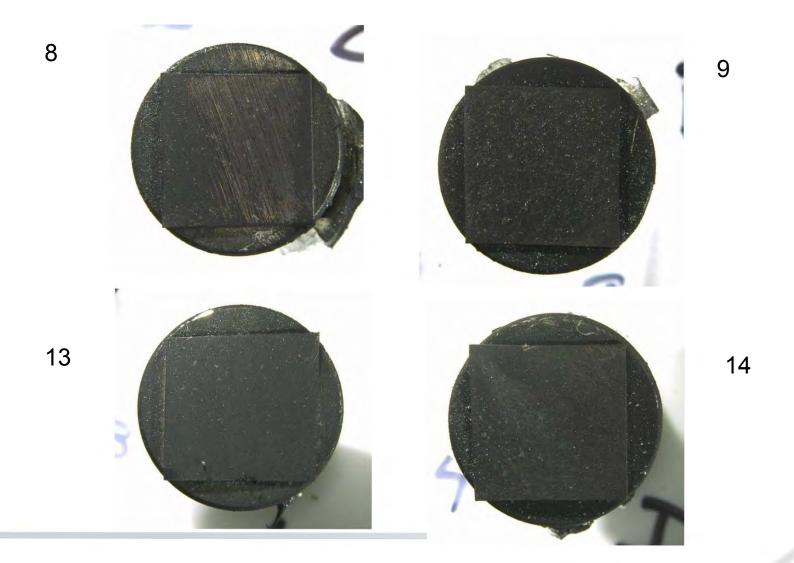


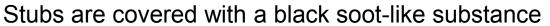
Laboratory Methods

- Scanning Electron Microscopy (SEM)
 - High resolution imaging.
 - Atomic number contrast.
- Transmission electron microscopy (TEM)
 - Ultra high resolution lattice imaging (crystallinity)
 - Electron diffraction crystallinity phase identification
- Energy Dispersive (X-ray) Spectroscopy (EDS) in the SEM/TEM
 - Semiquantitative elemental composition.
 - Elemental mapping and line scans.
- Fourier Transform Infrared (FTIR) spectroscopy
 - Identification of chemical functional groups.
 - Correlation with LWIR hyperspectral remote sensing signatures.
- Raman Spectroscopy
 - Identification of forms of carbon
- UV-VIS-NIR Spectroscopy
 - Measurement of darkening at UV-VIS-NIR wavelengths.



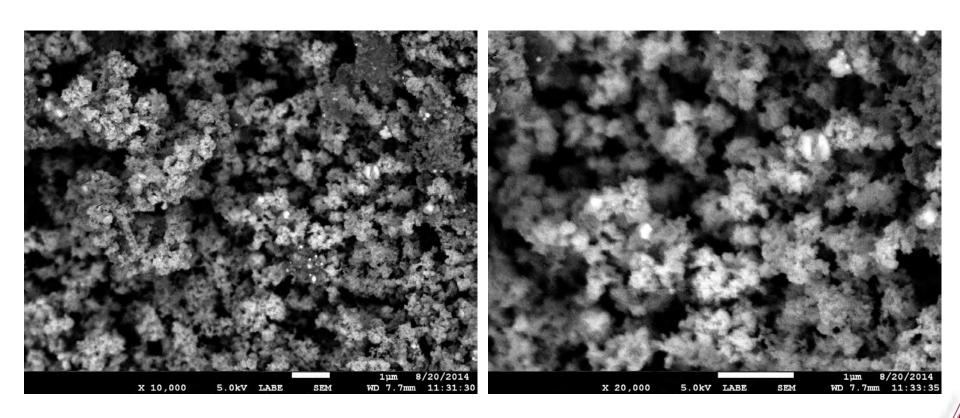
SBU Marking SEM Stubs (post test)







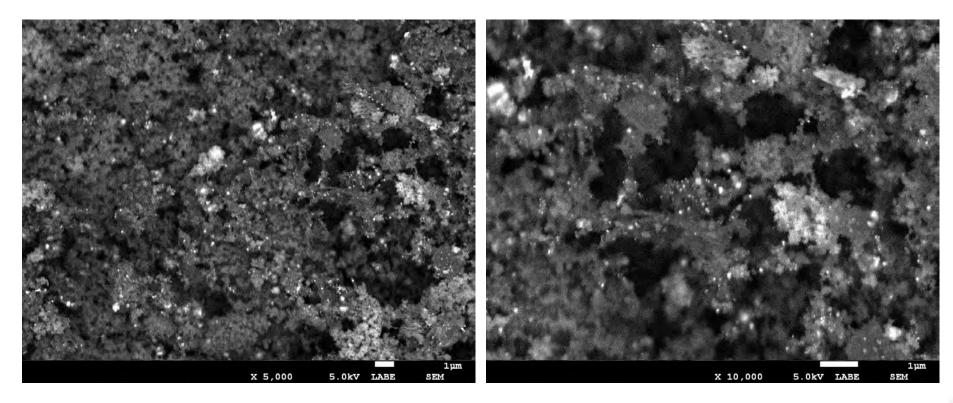
SEM Stub 4: Backscatter Electron SEM (10KX, 20KX)



Material on surface consists of nano-sized agglomerates



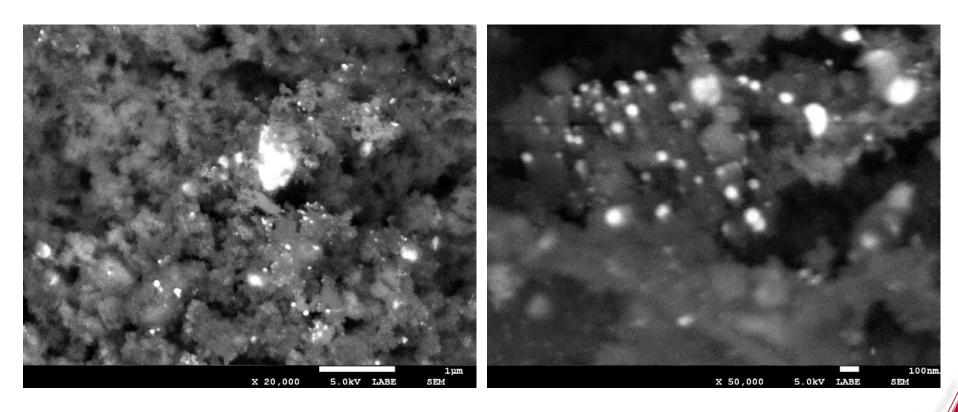
SEM Stub 9 Backscatter SEM 5KX, 10KX



Nano-sized bright areas are high Z (Fe, Cu, Zn Ge, Al) mixed with darker carbonaceous debris.



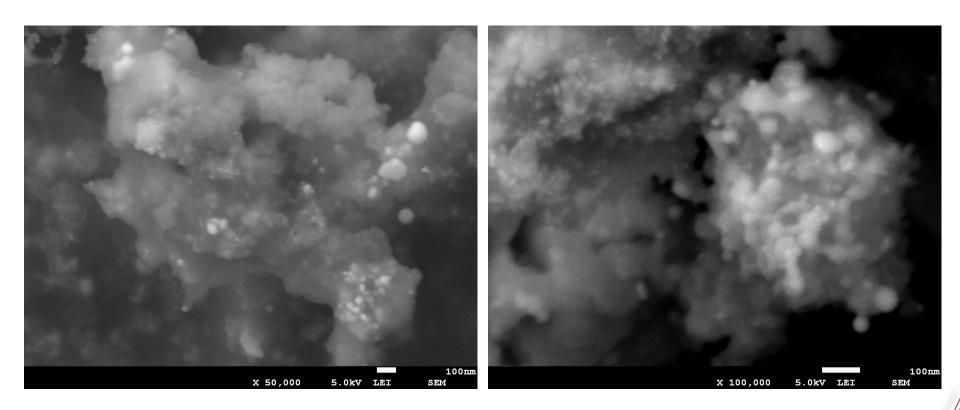
SEM Stub 9 Backscatter SEM 20KX, 50KX



Nano bright areas appear to be solidified molten droplets of high Z material (Fe, Cu, Zn Ge, Al) mixed and covered with carbonaceous debris.



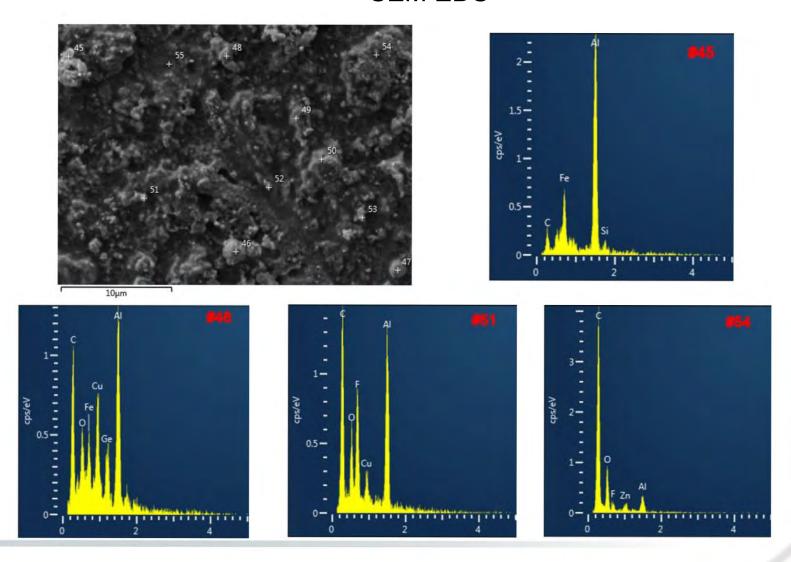
SEM Stub 13 Secondary Electron SEM (50KX, 100KX)



Note nano-scale particulates



SBU MSEM Stub 13 SEM EDS

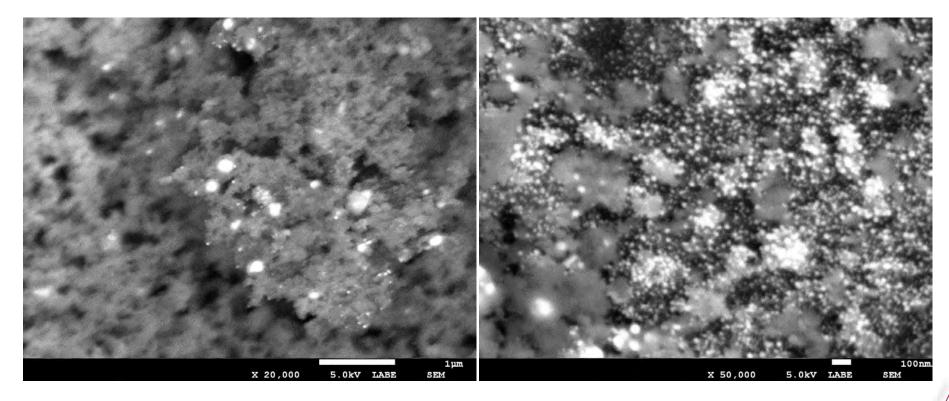


Al, C, F, Cu, O, Fe, and Ge are common. Bright nano droplets contain Fe, Cu, Ge.



SEM Stub 14

Backscatter SEM 20KX, 50KX

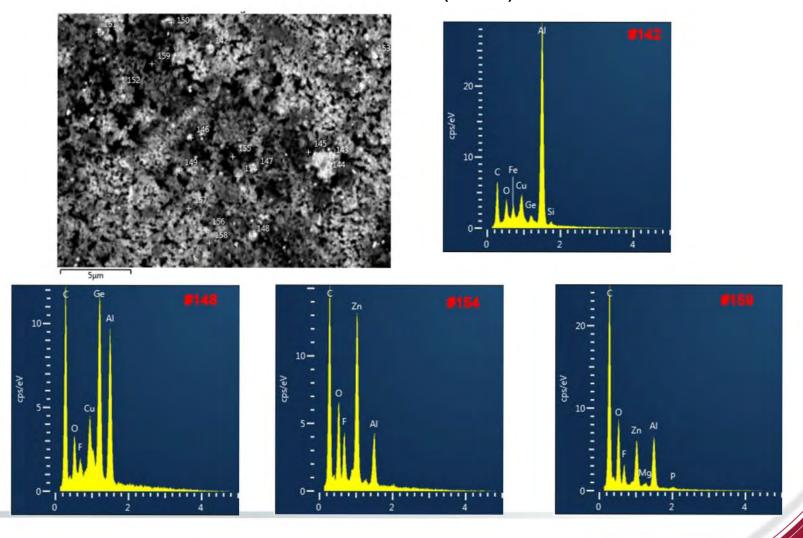


Majority of the deposit is an agglomeration of nano carbonaceous material

Note higher Z nano particles



SBU Marking SEM Stub 14 SEM EDS (5 KV)

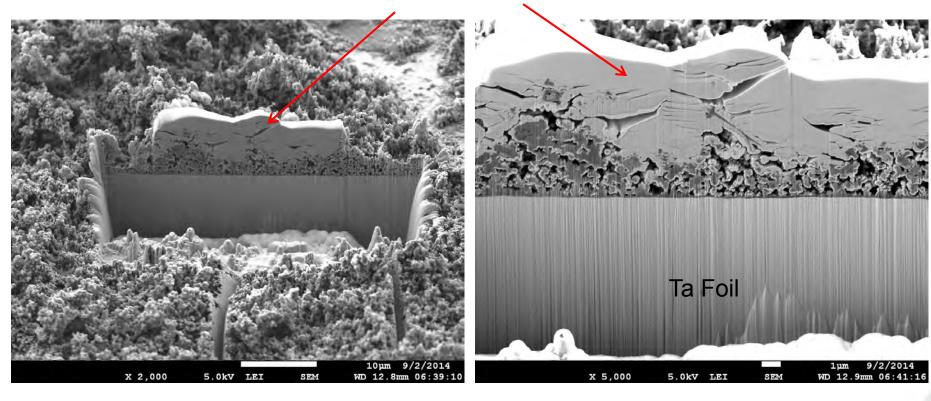


C is ubiquitous - AI, Zn, Ge, F and Cu are common.



SEM Stub 14: Focused Ion Beam (FIB) Cross Section Secondary Electron SEM 2KX, 5 KX

Protective Pt Layer



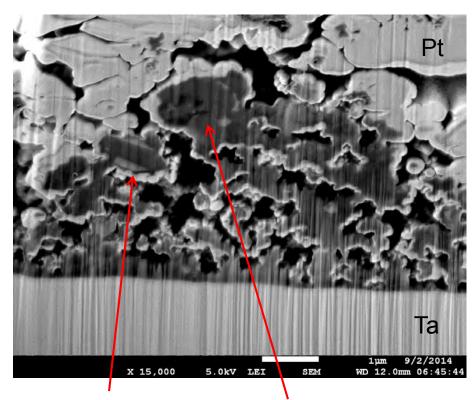
45 degree tilt

Deposit is several microns thick consisting of loose debris which is composed of agglomerates of nano particles.

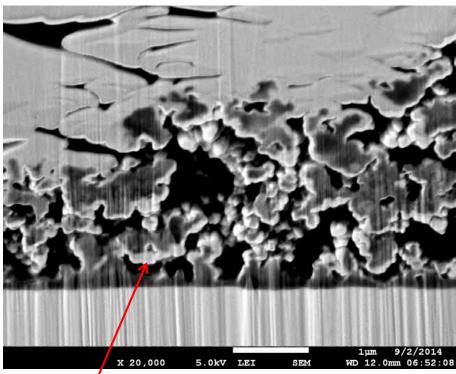


SEM Stub 14: FIB Cross Section

Backscatter Electron SEM 15KX, 20 KX



Higher Z fragments in carbonaceous matrix



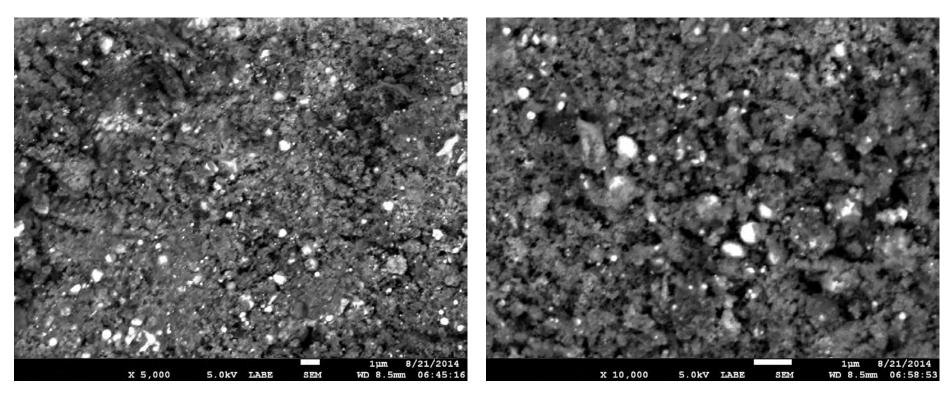
Light rind on particles is probably Ta ejected into cavities during the trenching operation or infusion of Pt.

EDS analysis was hampered by relatively large sampling volume and introduction of significant Pt, Ta and Ga. C, O and some Al detected.



SEM Stub 20

Secondary Electron SEM 5KX, 10KX



Material on surface consists of nano-sized agglomerates.

Darker areas are carbon rich. Bright spots contain Fe, Cu, Zn, Ge and represent solidified molten droplets partially covered with carbonaceous nano particles.



Summary of Area EDS Analyses

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V	Stub #4	Stub #13	Stub #14	Stub #9	Stub #20
C	57.7	78.0	61.9	61.1	61.7
0	20.1	11.9	16.1	18.8	16.2
F	7.4	1.8	4.4	5.7	2.9
Na	0.90	0	0	0.35	0
Mg	0.27	0.12	0.38	0.36	0.39
Al	5.4	3.6	5.8	8.7	12.5
Si	1.1	0.53	0	0.88	0.45
P	0	0.11	0.30	0.28	0.35
S	0	0	0	0.03	0
CI	0.13	0.09	0.12	0.10	0
Cr	0	0	0.03	0.16	0.38
Fe	0.28	0.22	0.28	0.64	1.42
Cu	0	0.09	0.14	0.25	1.27
Zn	3.4	0.16	7.7	1.9	2.0
Ge	0.07	0	0	0.18	0.40
Та	3.4	3.4	2.9	0.40	0
Distance	9 ft	11 ft	15 ft	17 ft	19 ft
Down					
Range					
Azimuth*	9 O'clock	3 O'clock	3 O'clock	12 O'clock	End Panel

All values atomic %

Ta is from the underlying Ta sheet

Averages of (2) 12 mm² areas

No consistent trends in elemental distribution.



^{*} Facing down range

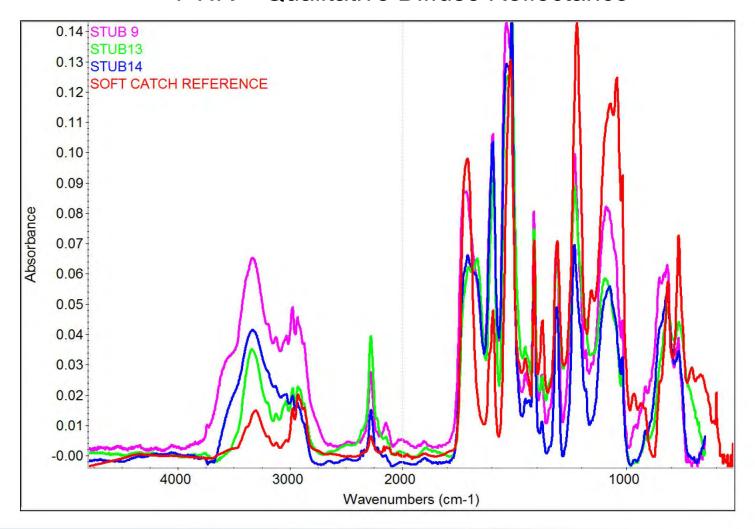
Summary of Area EDS Analyses

- The majority of the deposits consist of carbon and oxygen (77-89 at%).
 - Primarily from pyrolyzed soft catch (based on Debris-LV results).
 - Some contribution form MLI and C-C composite face sheet.
- Fluorine (1.8 7.4 at%) is from Teflon wire insulation and?
- Metal nano particles are common
 - Aluminum (3.6 12.5 at%) is from the aluminum honeycomb panels, structural core, nadir-zenith panels and COPV tank.
 - Zinc (0.2 7.7 at%) is from an unidentified source.
 - Iron (0.2 1.4 at%) is from stainless steel tubing and solenoids.
 - Copper (0.09 1.3 at%) is from wiring and solenoids.
 - Germanium (0.07 0.40 at%) is from the solar cells.



Post Test: SEM Stubs

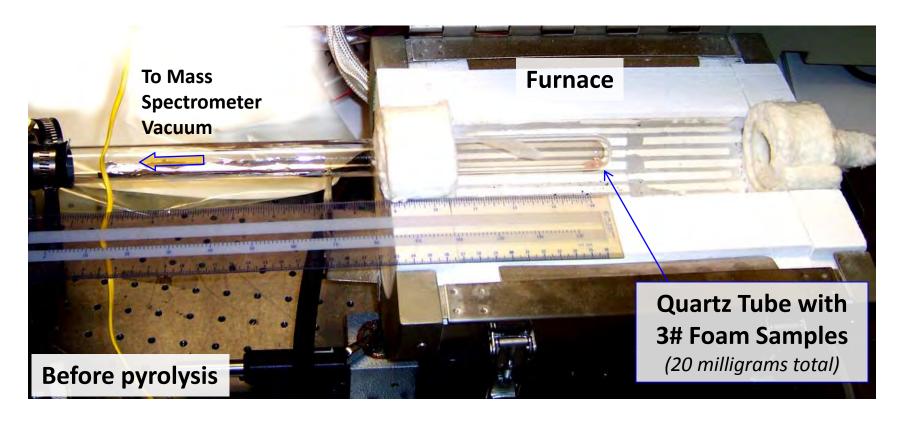
FTIR – Qualitative Diffuse Reflectance



Significant soft catch signature is present on SEM stubs. Some, but not all, is in the form of soft catch foam fragments which give samples a sparkly appearance.



Laboratory Foam Pyrolysis Experiment



~ 0.001 Torr Throughout Pyrolysis => λ ~ 10 inches

30 milligram pieces of 3# foam pyrolyzed in a quartz tube under vacuum in order to simulate exposure to plasma from hypervelocity impact.

Condensate residues in cool portion of tube outside the furnace were analyzed by FTIR.

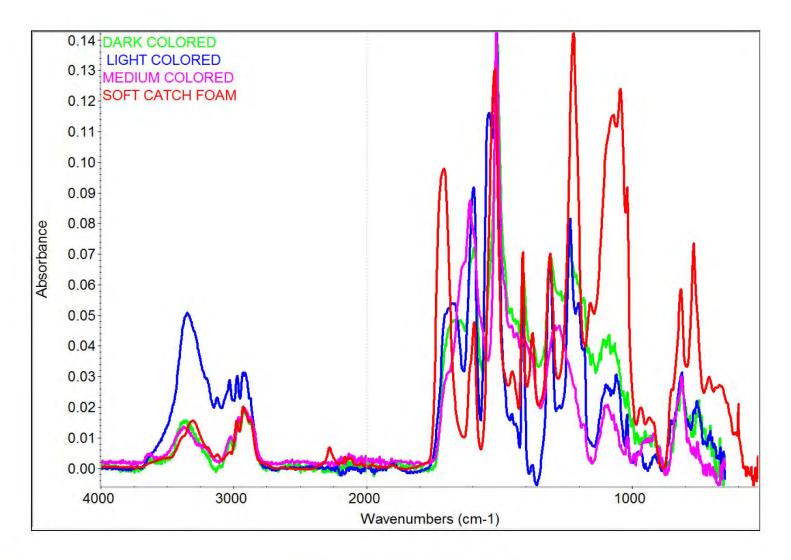


Laboratory Foam Pyrolysis Experiment

Carbonized Medium colored Light Deposit deposit Residual Foam Dark deposit 1 inch Diameter **Quartz Tube** After pyrolysis Progressively Cooler Heated Zone (1000°C) Condensation



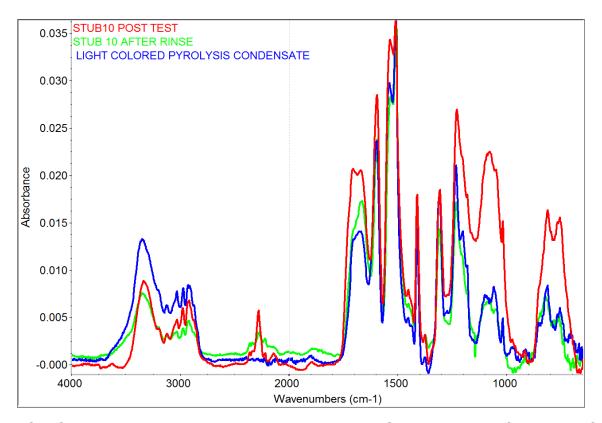
SBU Marking Condensate Removed from Tube



Various colors of condensate have similar but slightly different spectra that resemble soft catch foam.



Debris-LV Stub 10 vs. Pyrolysis Condensate

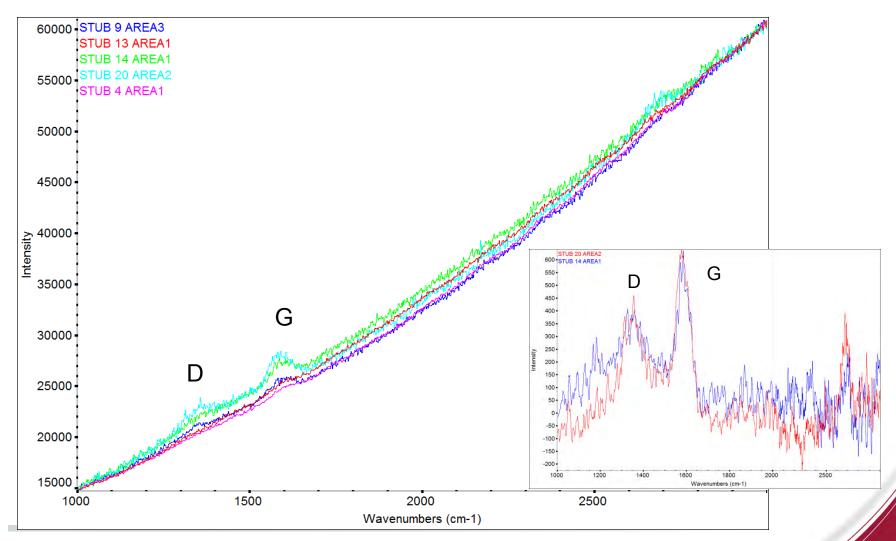


- Spectrum of soft catch condensate is similar to that on SEM stubs, before <u>and after rinsing</u> <u>stubs with isopropyl alcohol (IPA)</u>. Alcohol rinse only removed loose fragments.
- •SEM stubs are covered with a thin layer of soft catch condensate in addition to fragments. Probably a result of close proximity to soft catch panels exposed to plasma.

Since DebriSat also used soft catch - SEM stubs are probably also covered with a thin layer of soft catch vapor condensate. DebriSat stubs were not rinsed with IPA.



SEM Stubs: Raman Spectroscopy



Disordered (D) and crystalline graphite (G) bands observed in some areas. Graphitic bands also seen in Debris-LV deposits.



Witness Plate: Post Test



Witness Plate Samples:

Direct Exposure

- (4) 1" fused silica (D)
- (1) 1" Z-93 painted Al
- (1) 1" Aluminum

Multi layer insulation

Protected Under Whipple Plates

- (2) 1" fused silica
- (1) 1" Z-93 painted Al
- (1) 1" Aluminum
- (1) 1" NaCl (cleaved)
- (1) Cu sheet

Ge ATR crystal (D)

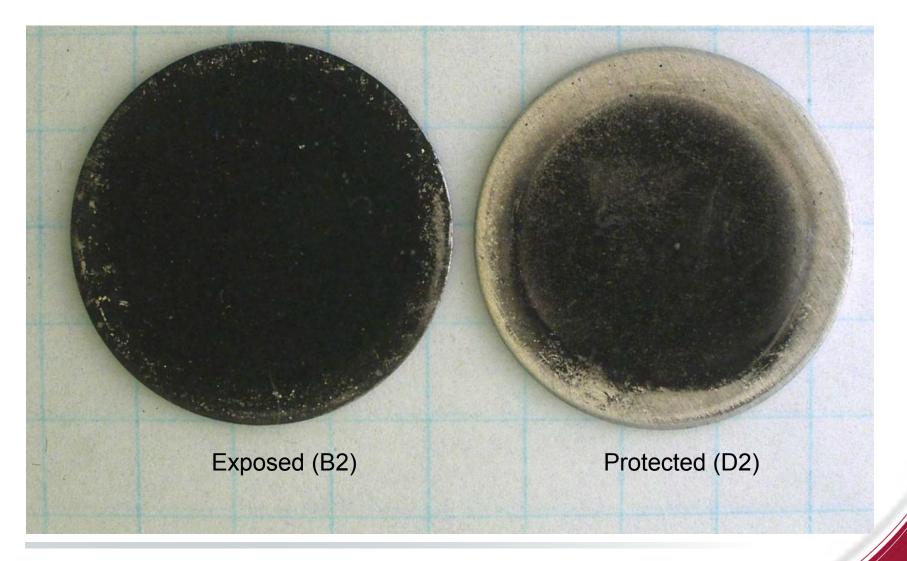
Solar cell

(D) = destroyed

Top Whipple plate received a significant impact. Assembly is completely covered with black soot. Many witness plate samples were fractured/destroyed.



Witness Plate Post Test: Aluminum Disks

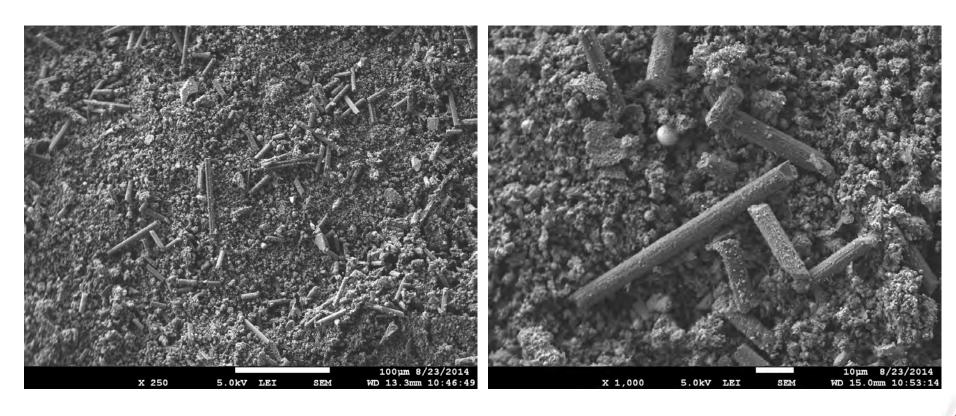


Significant accumulation of debris, especially on exposed disk



Witness Plate Post Test: Aluminum Disk B2 (exposed)

Secondary Electron SEM Images (250X, 1KX)

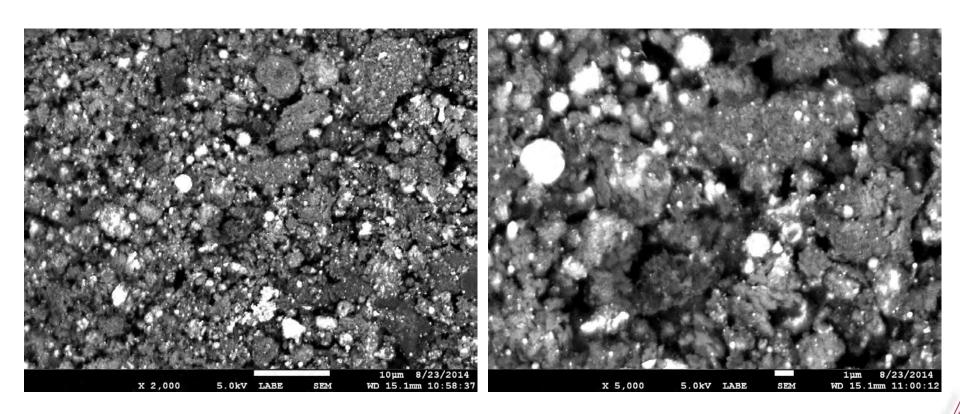


Note fragments of carbon fibers and round solidified droplets. Carbon fibers are from the composite face sheets on the honeycomb structural panels.



Witness Plate Post Test: Aluminum Disk B2 (exposed)

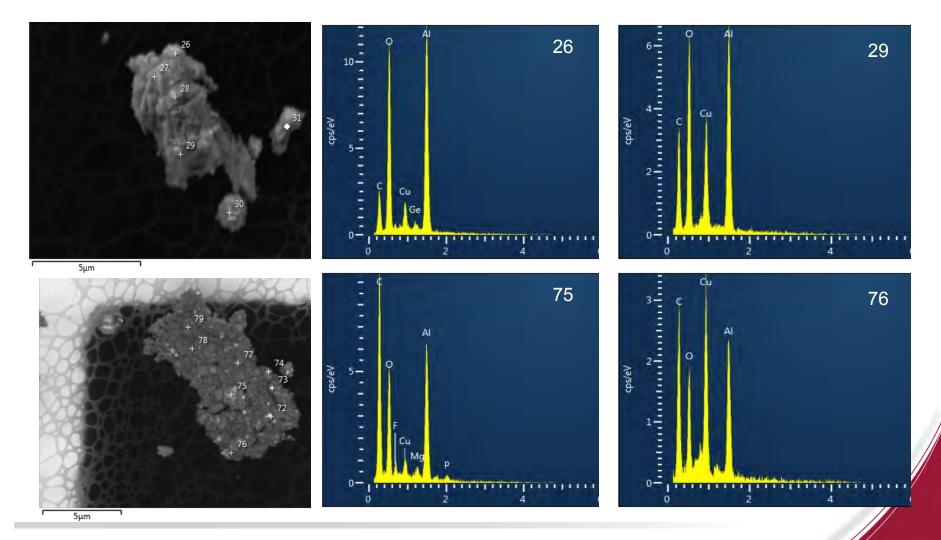
Backscatter Electron SEM Images (2KX, 5KX)



Round solidified droplets are higher Z (Al, Fe, Cu, Ge, Zn) and indicate melting of material as a result of impact.



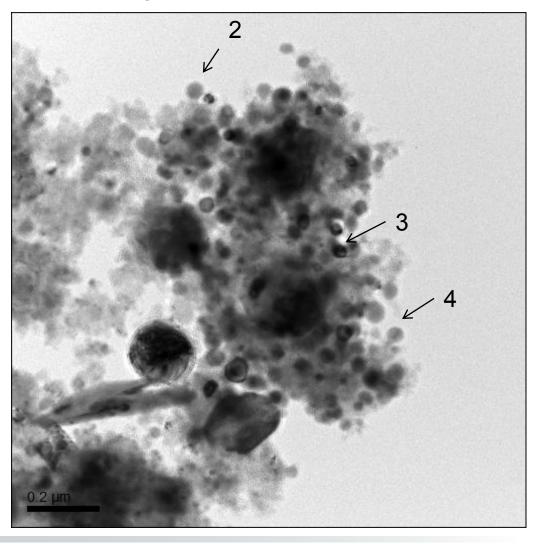
Witness Plate Post Test: Aluminum Disk B2 (exposed) SEM Images of particles suspended on lacey carbon films on Cu TEM grid



Particles are rich in C, O, Al and Cu. Minor C and Cu can be from grid but significant amounts are in the particles. Many particles appear to be aluminum oxide.



Witness Plate Post Test: Al Disk D2 Debris Transferred to TEM Grid: Bright Field (BF) - TEM

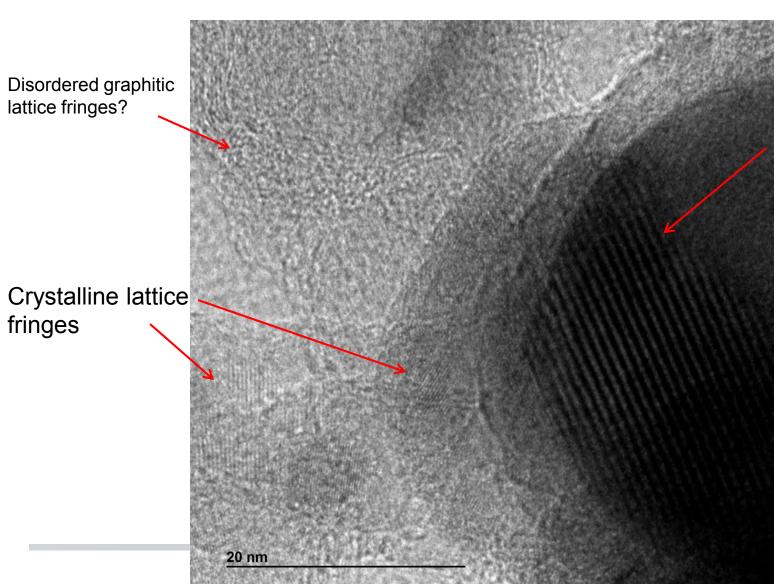


Location 5

Material is an agglomeration of nano particles. Diffraction contrast in some particles indicates crystallinity.



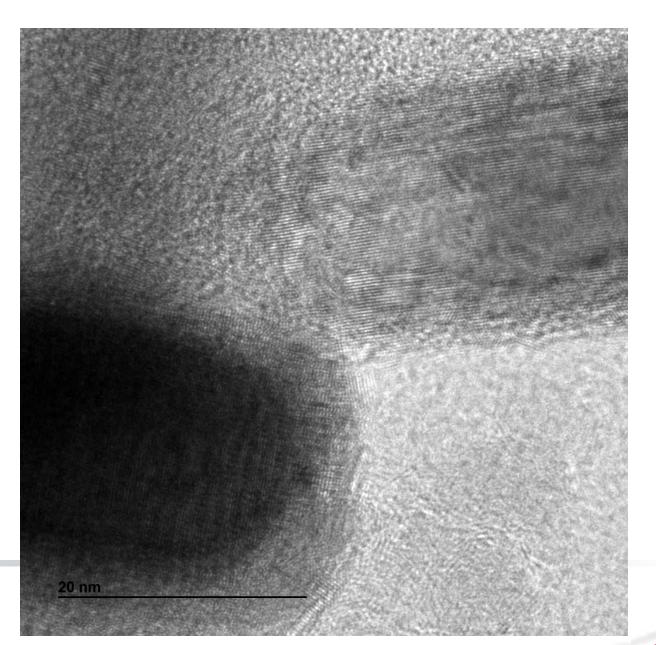
Witness Plate Post Test D2: Area 3 BF-TEM



Moire pattern from superimposed lattice fringes



Witness Plate Al Disk D2: Location 4 Area 6 BF-TEM



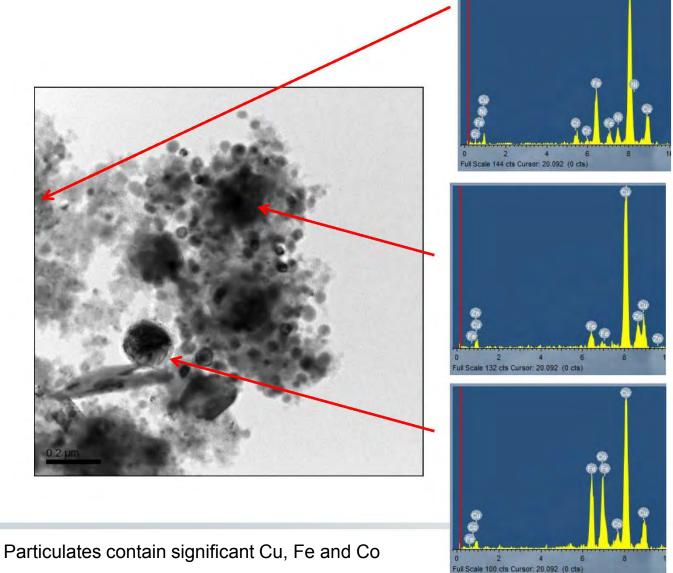
Crystalline lattice fringes (0.256 nm). ZnO (002) = 0.260 nm

Particle is nominally a single crystal.



SBU Marking

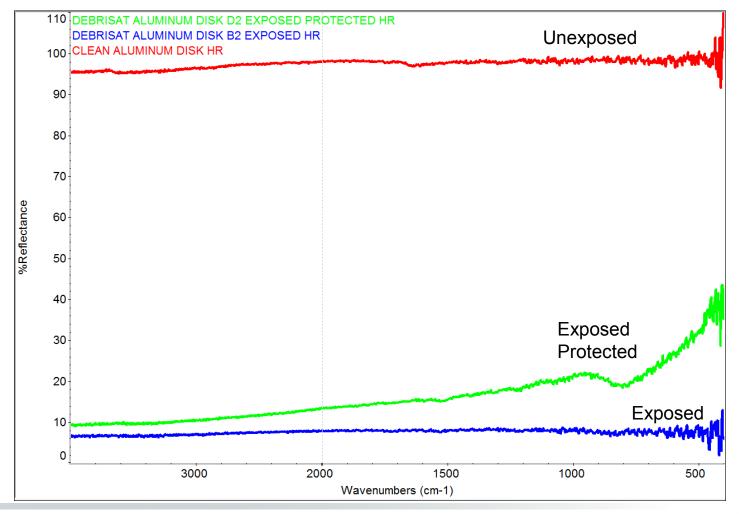
Witness Plate Post Test: D2 Location 5 TEM - EDS





Witness Plate Post Test: Aluminum Disks (B2, D2)

Quantitative LWIR FTIR Hemispherical Reflectance

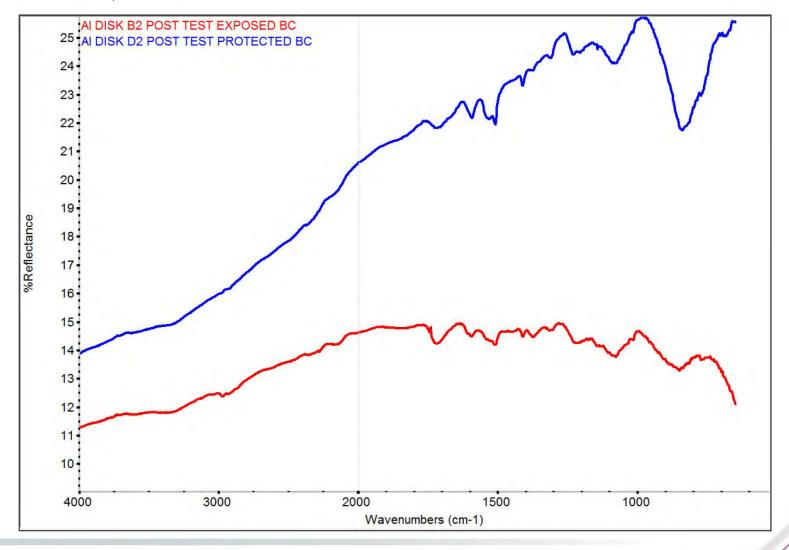


Significant darkening from 95% to 6% reflectance.



Witness Plate中的时间est Aluminum Disks

Qualitative LWIR FTIR Biconical Reflectance



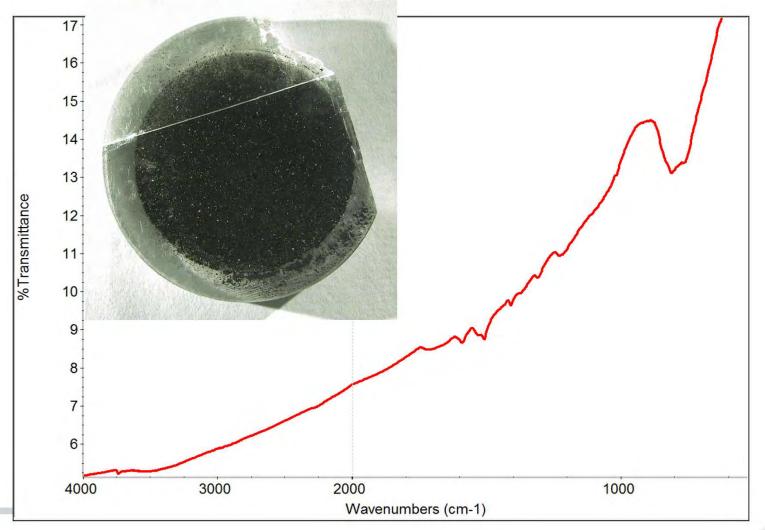
Soft catch contamination plus additional "oxide" band at 800 cm⁻¹. May be an aluminum oxide. Similar band seen in Debris-LV.

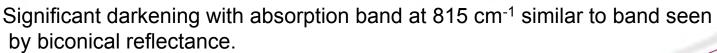


SBU Marking

Post Test: Protected NaCl Disk

LWIR FTIR Transmission

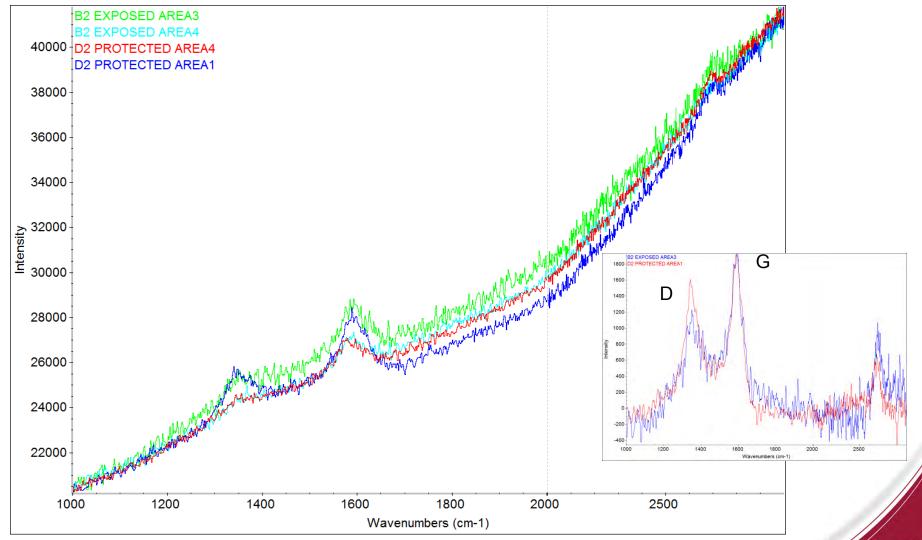






Witness Plate Post Test Al Disks

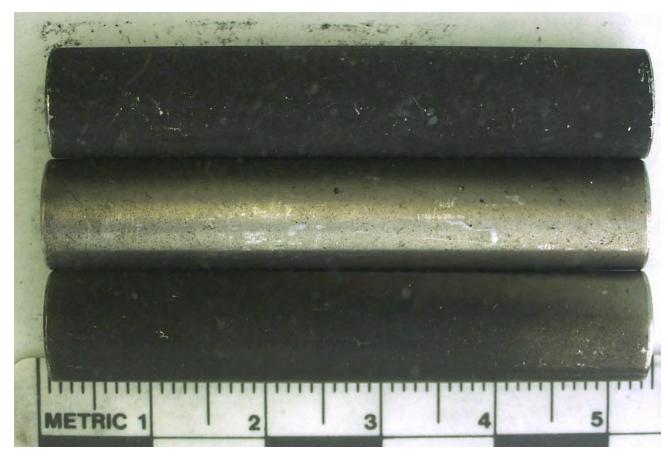
Raman Spectroscopy



Disordered (D) and crystalline graphite (G) bands observed in some areas. Similar to SEM stubs.



Witness Plate Whipple Plate Support Posts



Unrinsed covered with black soot

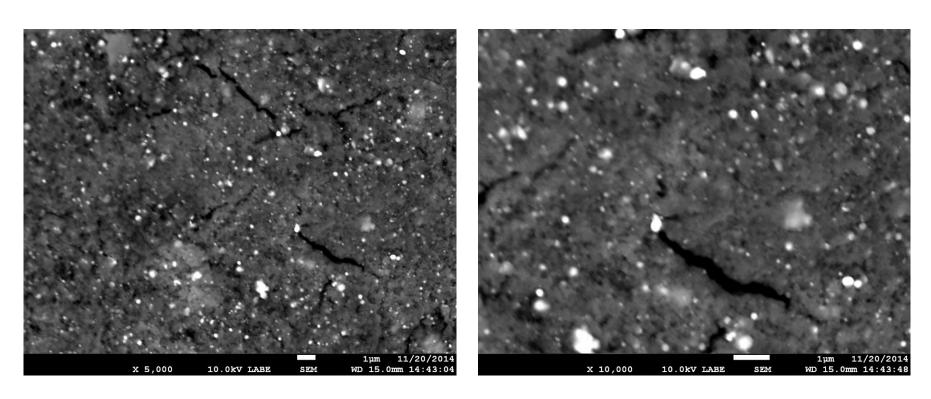
Rinsed Side 1

Rinsed Side 2

After rinsing with isopropyl alcohol the loose black soot is removed. One side is relatively clean but a resistant black coating remains on one side indicating directional deposition.



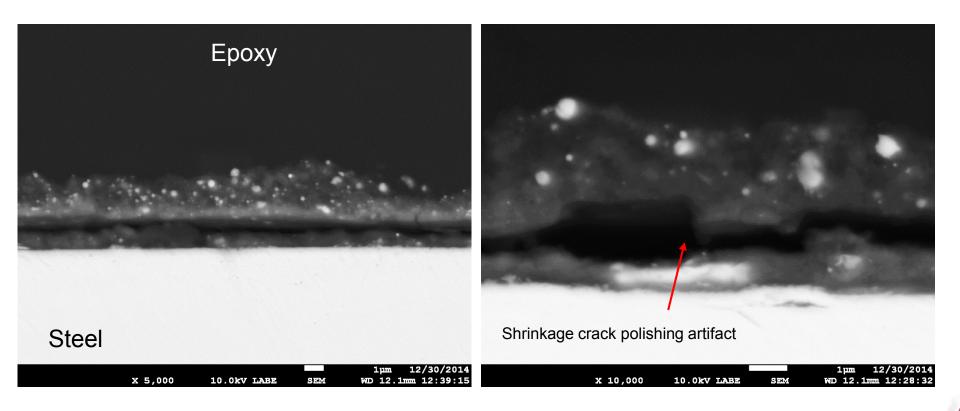
Rinsed Whipple Plate Support Post (surface) Backscatter SEM 5KX, 10KX



High Z (Al, Fe, Cu) nanoparticles embedded in carbonaceous matrix.



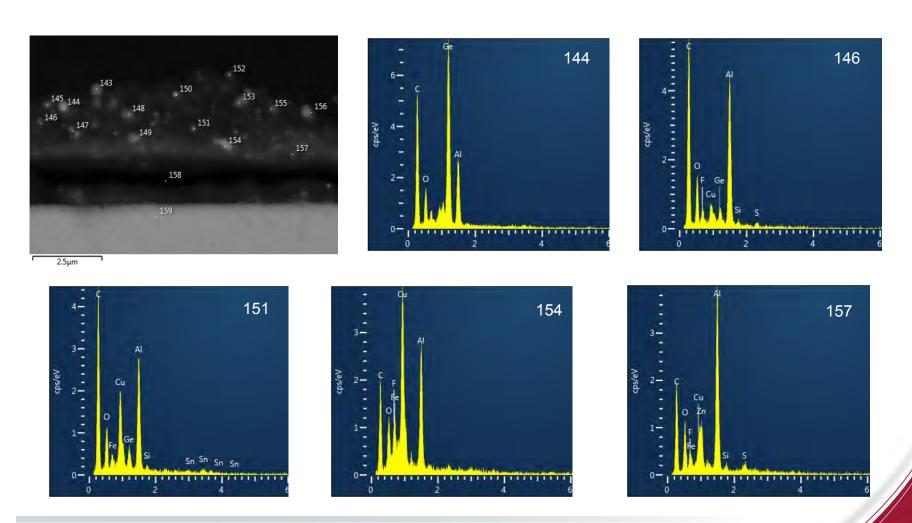
Rinsed Whipple Plate Support Post (polished cross section) Backscatter SEM 5KX, 10KX



Metal nano droplets in a carbonaceous matrix 2-3 microns thick.



Rinsed Whipple Plate Support Post Deposit Backscatter SEM EDS Spectra



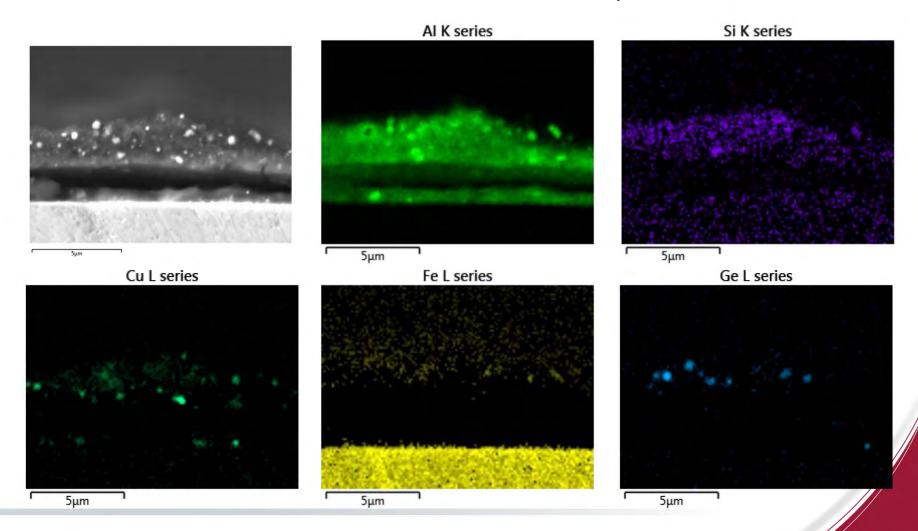
High Z nano particles in carbonaceous matrix contain Al, Cu, Ge, Fe and Zn.



SBU Marking

Rinsed Whipple Plate Support Post Deposit

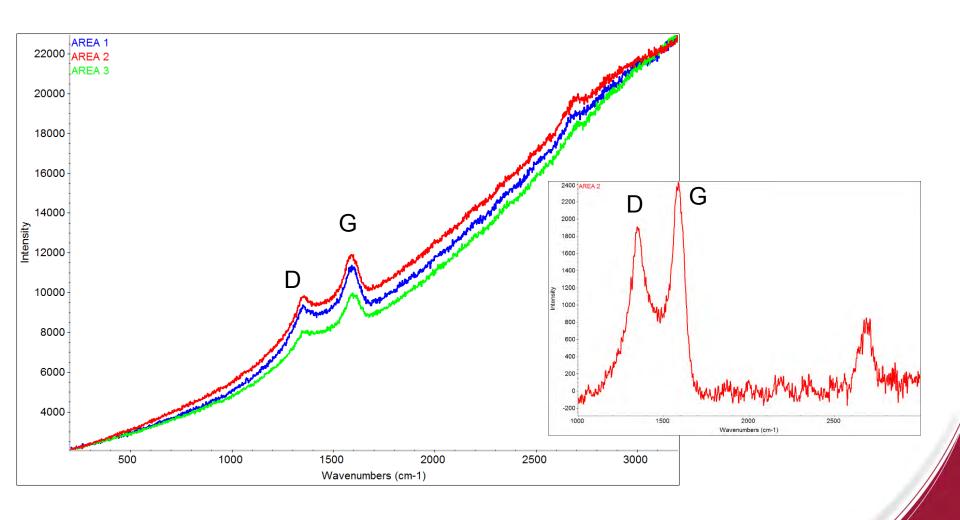
Backscatter SEM and EDS maps



High Z nano particles in carbonaceous matrix contain Al, Cu, Ge, Fe,



Witness Plate Spacer: Raman Spectroscopy



Disordered (D) and crystalline graphite (G) bands observed on dark side of spacer.



Summary of Observations

- SEM stubs, witness plate assembly and DebriSat fragments were contaminated with soft catch fragments.
- SEM stubs also had a thin film of condensed soft catch vapor.
 - Similar to Debris-LV.
- Deposits on SEM stubs and witness plate assembly are predominantly C and O and consist of agglomerates of nano carbonaceous material.
 - Deposits are primarily from the soft catch similar to Debris-LV
 - C-C composite honeycomb face sheets and MLI are also possible sources.
- Disordered graphitic carbon is present based on Raman spectra and TEM lattice fringe images. Similar to Debris-LV.
- The witness plate assembly was covered in a layer of loose "soot", even under the protective Whipple plates.
 - Removal of the loose material by rinsing with isopropyl alcohol revealed a thin adherent coating on <u>one side</u> of the support posts indicating early directional deposition from DebriSat.
 - Coating was carbonaceous (disordered graphite) with nano metal particles.



Summary of Observations (cont.)

- Fluorine from Teflon wire insulation is also common.
- Nano droplets of metallic materials (Al, Fe, Cu, Zn, Ge) are also present indicating melting as a result of impact. Nano metal droplets also seen in Pre Preshot and Debris-LV.
 - Al is from the Al honeycomb, nadir and zenith panels, structural core and COPV liner.
 - Aluminum oxide particles are also present.
 - Al projectile is another source of aluminum.
 - Fe is from SS tubing and solenoids.
 - Ge is from the solar cells
 - Cu is from wiring and solenoids
- Solidified molten nano metal droplets are crystalline based on TEM lattice fringes and consist of only a few crystallites.



Summary of Observations (cont.)

- Witness plates show a significant decrease in reflectance (95% to 6%)
- Soft catch contamination seen in LWIR reflectance spectra of DebriSat fragments, SEM stubs and witness plate.
 - Not possible to get a clean spectrum of the debris generated by the hypervelocity impact
 - Additional "oxide" band at 800 cm⁻¹ seen on some samples.
- Other laboratory analyses documented:
 - Aerospace TOR-2014-03201, Time-resolved Spectroscopy of Hypervelocity Impact Flash on DebriSat, Gouri Radhakrishnan.
 - Aerospace ATM-2014-03659, DebriSat Hypervelocity Impact Fragmentation Modeling, Naoki Hemmi



Appendix 1

Supplemental Information and Analyses



Introduction (cont.)

- Pre Preshot was conducted February 2014.
 - Validated performance of projectile to meet velocity goal of 7 km/s.
 - Confirmed operational status of test chamber and facility.
 - Target was primarily designed to catch the projectile.
 - Multi-shock shield supplied by NASA.
 - Multiple bumper panels of fiberglass, stainless steel mesh and Kevlar.
 - No "soft catch " panels were installed (unlike Debris-LV and DebriSat).
 - Test conducted with a pressure of ~1-2 Torr nitrogen.
 - A witness plate assembly was provided by Aerospace in order to catch and sample debris.
- Additional Documentation
 - Aerospace TOR- 2014-03082, DebriSat Pre Preshot Laboratory Analyses,
 P. M. Adams and P. M. Sheaffer, December 23, 2014.



Introduction (cont.)

- Debris-LV (Pre Shot) conducted 1 April 2014
 - Further validated performance of projectile and facility and served as a dress rehearsal for the DebriSat test.
 - The 15 kg target consisted primarily of empty tanks and was constructed by Patti Sheaffer from materials representative of a launch vehicle (LV) upper stage.
 - Primarily aluminum and titanium with lesser amounts of copper and stainless steel.
 - Test chamber was lined with "soft catch" foam panels to trap fragments for size distribution analysis.
 - A witness plate assembly was constructed by Aerospace in order to catch and sample debris and returned to Aerospace after the test for analysis.
 - Aerospace also placed SEM stub witness plates into soft catch for post test retrieval and analysis.
- Additional documentation
 - Aerospace TOR-2014-03577, Debris-LV Hypervelocity Impact Post-Shot Physical Results Summary, P. M. Sheaffer.
 - Aerospace TOR-2015-00928, Debris-LV Laboratory Analyses, P. M. Adams, P. M. Sheaffer, Z. R. Lingley and G. Radhakrishnan.



Laboratory Instrumentation

- Field Emission Scanning Electron Microscopy (FESEM)
 - JEOL JSM-7600F SEM.
 - In-lens secondary electron detector (SEI mode).
 - High resolution imaging.
 - Lower secondary electron detector (LEI mode).
 - Less charging.
 - Enhances topography.
 - Backscatter electron detector (LABE mode)
 - Atomic number (Z) image contrast.
- Energy Dispersive (X-ray) Spectroscopy (EDS) in the SEM/TEM
 - Oxford X-Max silicon drift detector (SEM).
 - Oxford SiLi detector (TEM)
- Transmission Electron Microscopy (TEM)
 - JEOL JEM-3100F TEM.
 - Oxford INCA EDS.



Laboratory Instrumentation (cont.)

- Fourier Transform Infrared (FTIR) spectroscopy
 - Nicolet 6700 spectrometer.
 - Harrick Scientific "praying mantis" diffuse reflectance accessory.
 - Qualitative reflectance.
 - Mercury cadmium telluride (MCT) detector.
 - Fast analysis with excellent signal to noise.
 - Can only analyze small samples (< 1").
 - Labsphere hemispherical reflectance accessory.
 - Quantitative reflectance.
 - Long scan time with poor signal to noise.
- Raman Spectroscopy
 - Renishaw inVia Raman microscope.
- UV-VIS-NIR Spectroscopy
 - Perkin Elmer Lambda 900 Spectrometer
 - Diffuse transmission and reflectance with integrating sphere.

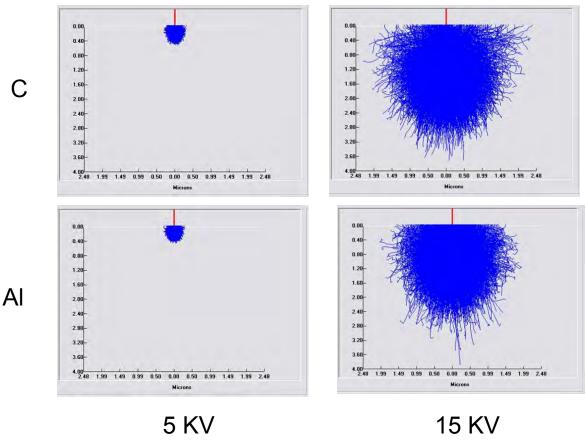


Considerations for SEM and EDS Analyses

- A preliminary look at Debris-LV and DebriSat SEM stubs indicated that a thin coating, containing low atomic number (Z) materials (carbon), was present.
- This presented challenges and options for SEM-EDS analyses. Low vs. high voltage (5 KV vs. 15 KV).
- Advantages of 5 KV: high resolution imaging of thin low Z surfaces, EDS from surface material and not substrate.
- Disadvantages of 5 KV: beam does not penetrate beneath the surface (subsurface is hidden), does not excite X-rays from medium Z elements (Cl to Ti), high Z element K series not excited but L series X-rays are.
 - Most medium Z elements not expected .
- Advantages of 15KV: Can see a limited distance beneath the surface, excites X-rays from just about all elements.
- Disadvantages of 15 KV: loss of detail in low Z surfaces, for thin coatings may penetrate through to the substrate



Electron Penetration into Materials



- •Electron penetration influences depth of X-ray generation (EDS).
- •Secondary emitted electrons have low energy and image primarily the surface.
- •Backscattered emitted electrons have greater energy and image partially into the surface and have atomic number information.



SEM Stubs



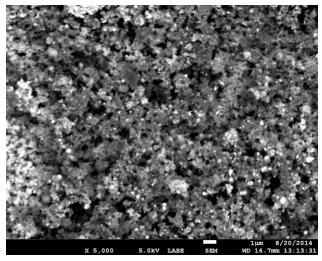
Unexposed Exposed #13 Exposed #14

Note significant darkening of post test stubs



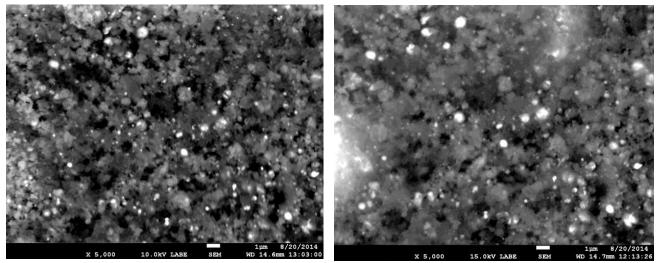
SEM Stub 4: Backscatter Electron SEM (5 KX)

Brighter areas are higher atomic number (Z).



5 KV





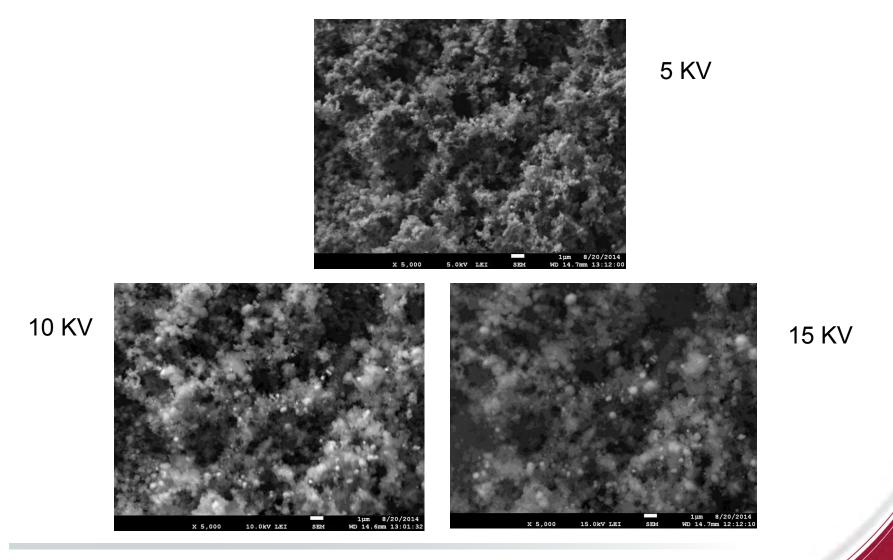
15 KV

Images are from the same area.

Greater penetration and less surface detail with increasing energy.



SEM Stub 4: Secondary Electron SEM (5KX)

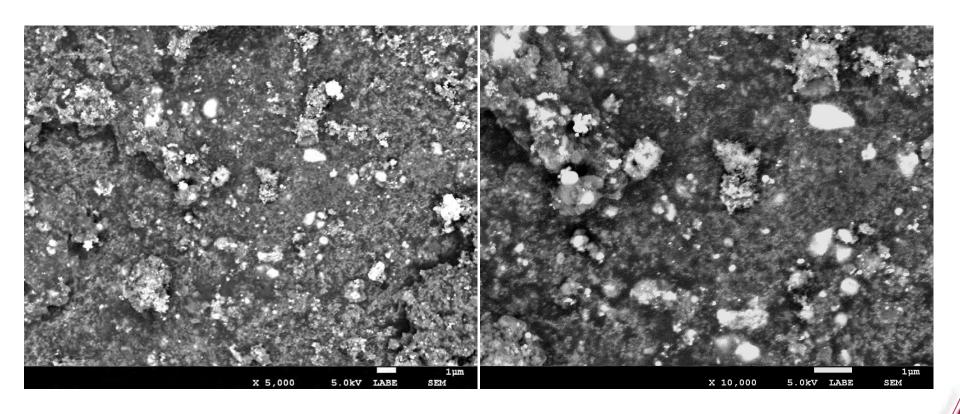


Images are from the same area as previous slide.

Greater penetration and less of surface detail with increasing energy.



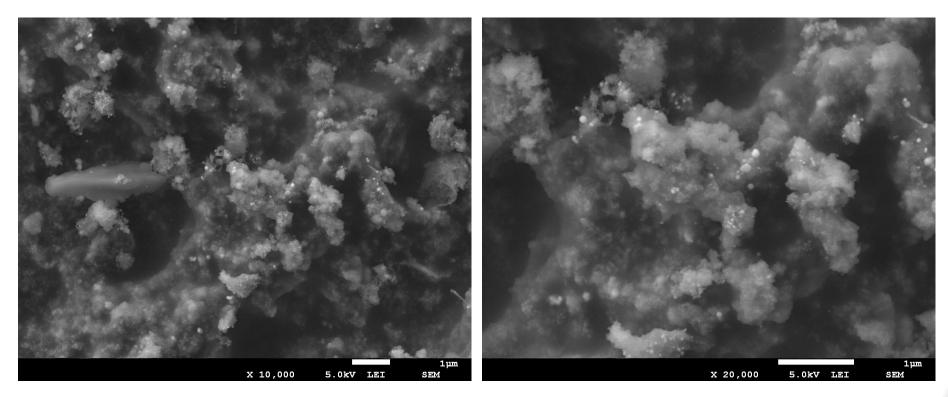
SEM Stub 13 Backscatter SEM (5KX, 10KX)



Material on surface consists of nano-sized agglomerates



SEM Stub 13 Secondary Electron SEM (10KX, 20KX)

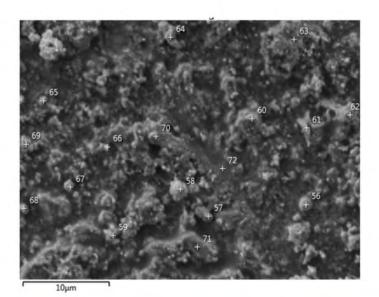


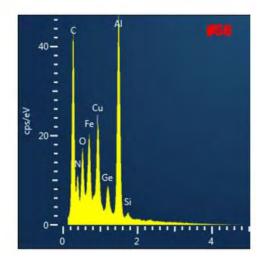
Note nano-scale structures

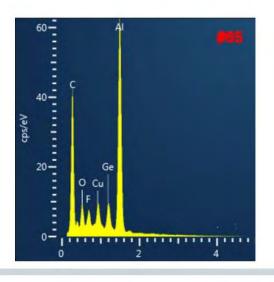


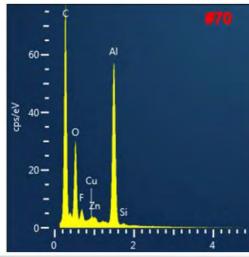
SBU MSEIM Stub 13

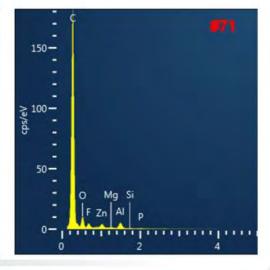
SEM EDS







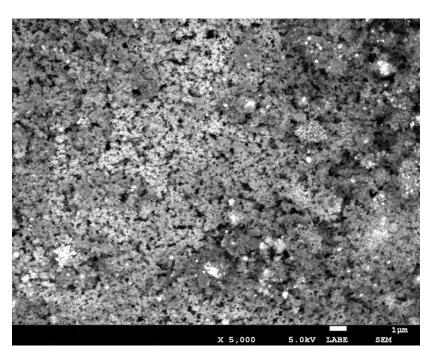


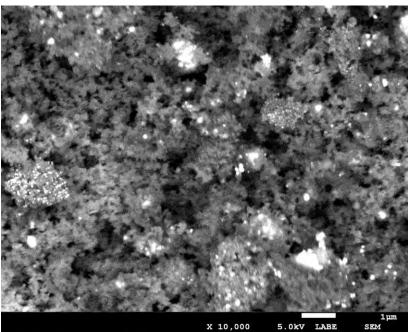


Al, C, Cu, O, Fe, and Ge are common.



SEM Stub 14 Backscatter SEM 5KX, 10KX



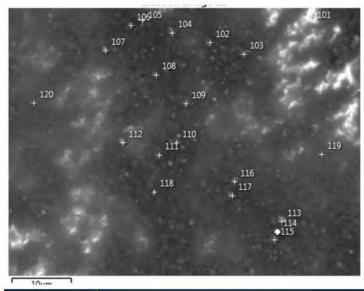


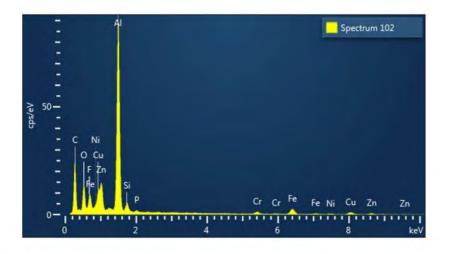
Material on surface consists of nano-sized agglomerates

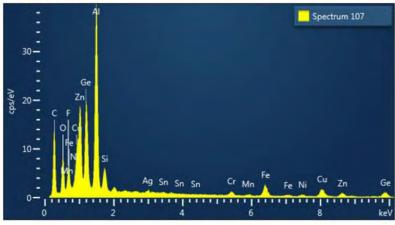


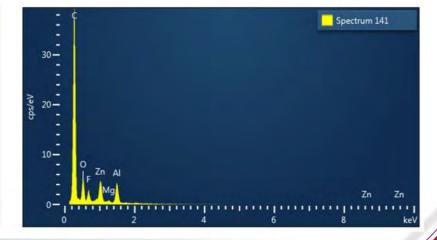
SBU Marking SEM Stub 14

SEM EDS (15 KV)









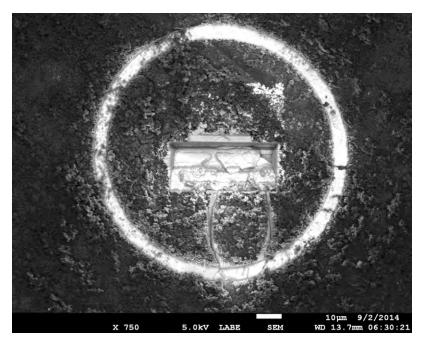


Al, C, Cu, O, Fe, Zn and Ge are common.

SEM Stub 14: Focused Ion Beam (FIB) Cross Section Backscatter SEM

Circle trenched down to Ta to facilitate site location

Protective Pt layer deposition





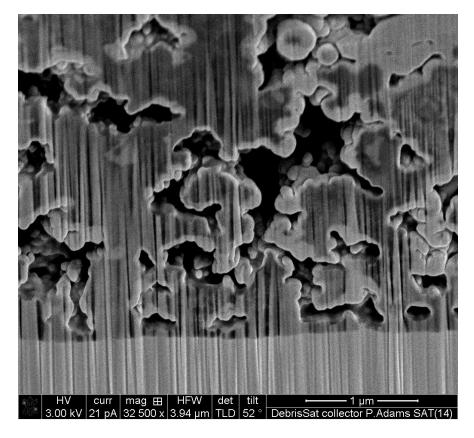
Vertical wall

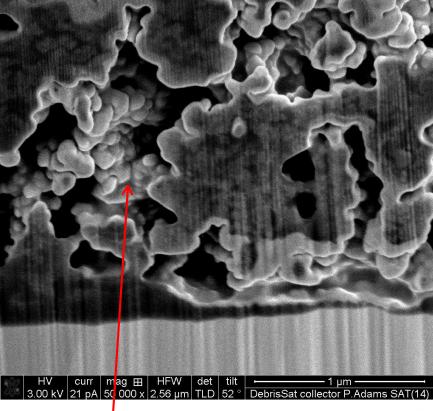
50 deg angled trench

Plan View



SEM Stub 14: FIB Cross Section SEM 32.5KX, 50 KX





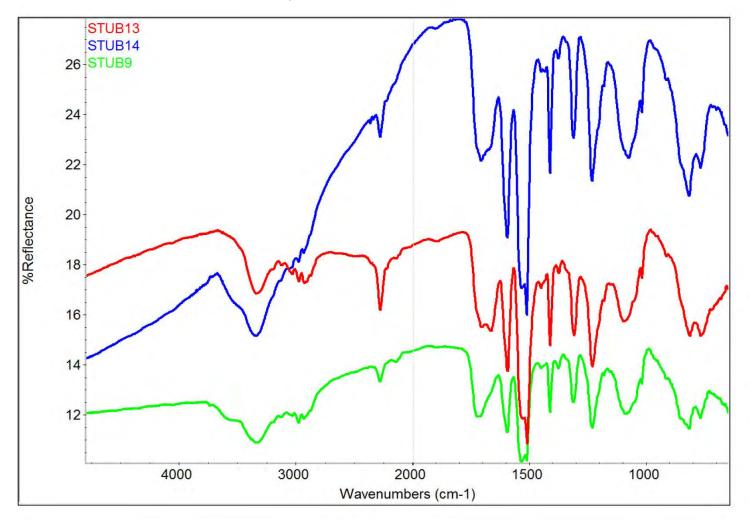
Striations (curtains) are artifacts of FIB preparation.

Back deposition of Ta from trenching into voids?



SBU Marking Post Test: SEM Stubs

FTIR – Qualitative Diffuse Reflectance







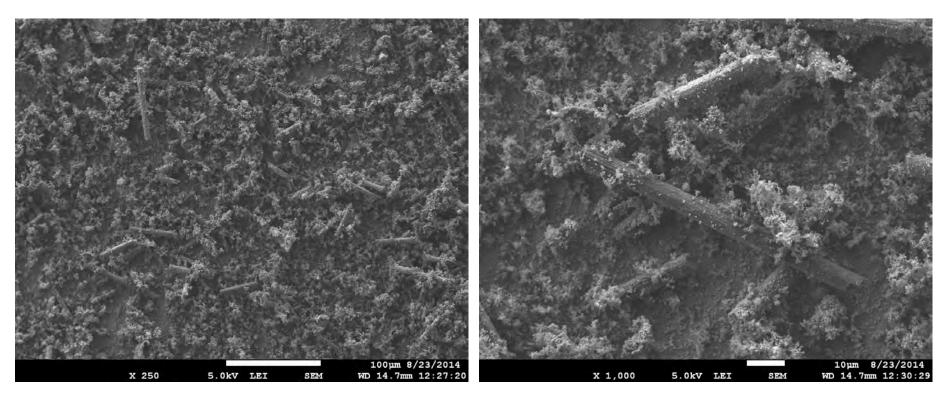
Witness Plate Assembly: Post Test



Witness plate is completely covered in black sooty debris – even protected areas under the Whipple plates.



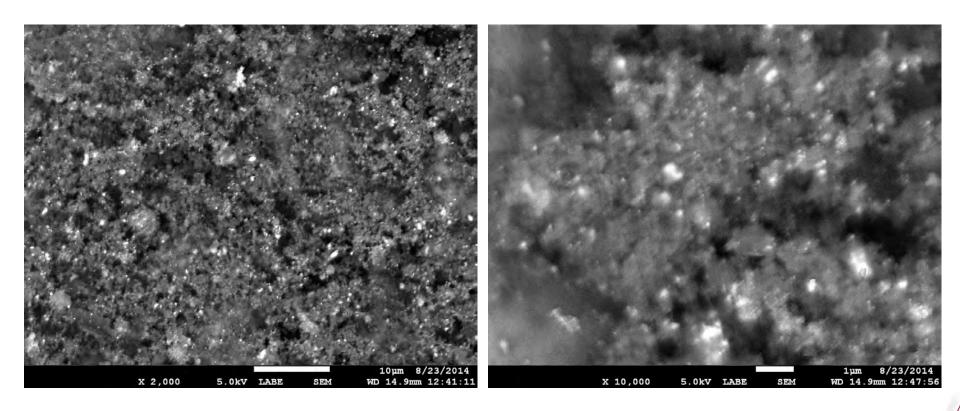
Witness Plate Post Test: Aluminum Disk D2 (protected) Secondary Electron SEM Images (250X, 1KX)



Note fragments of carbon fibers.



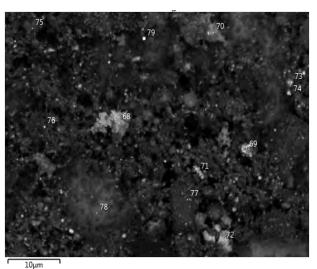
Witness Plate Post Test: Aluminum Disk D2 (protected) Backscatter Electron SEM Images (2KX, 10KX)

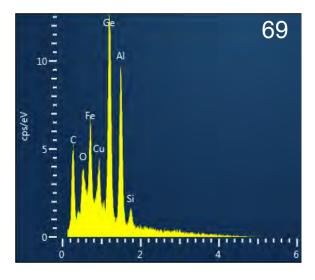


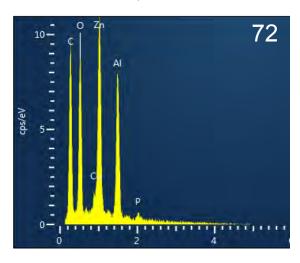
Agglomerates of nano carbonaceous material and solidified molten droplets of higher Z material

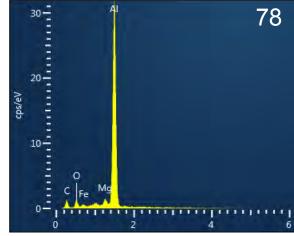


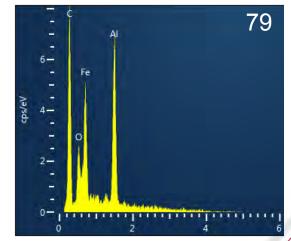
Witness Plate Post Test : Aluminum Disk D2 (protected) SEM EDS Spectra (5KV)







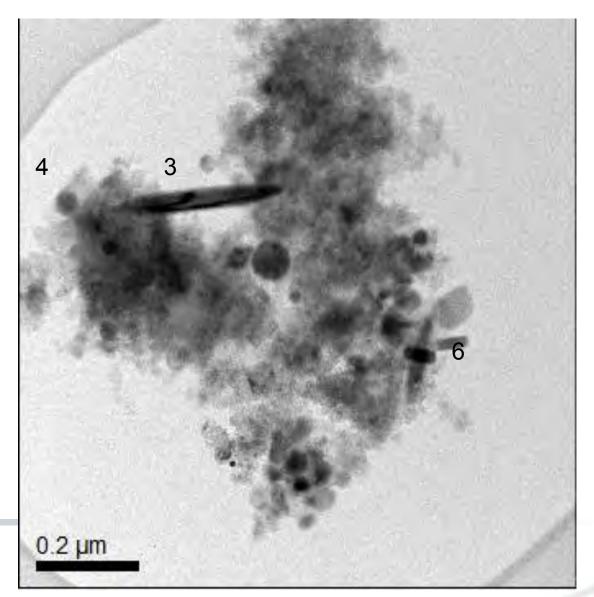






Al, C, Cu, O, Fe, Zn and Ge are common.

Witness Plate Al Disk D2: Loose Material on TEM Grid: BF TEM Location 4





SBU Marking

Witness Plate Post Test D2: Area 2 BF-TEM

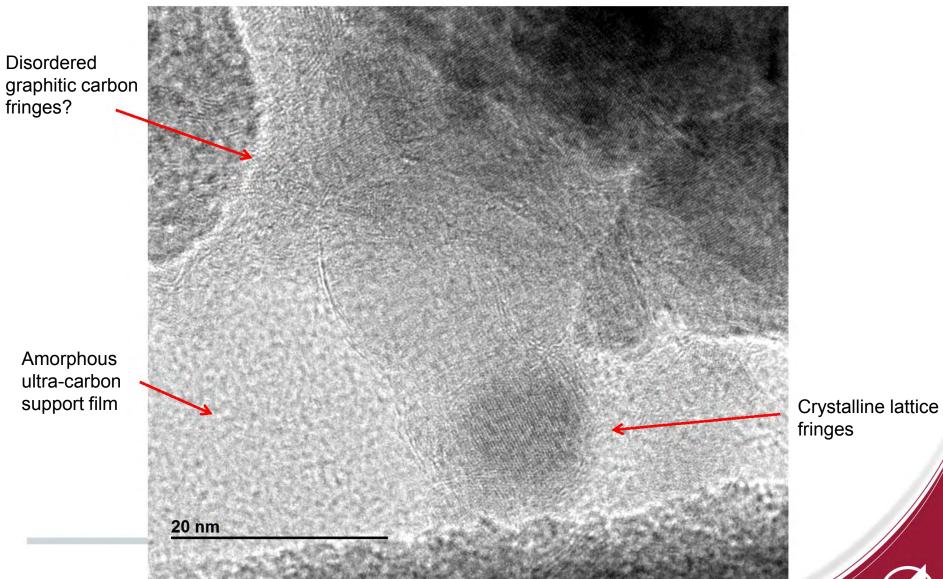
Crystalline lattice fringes

Amorphous C support film 20 nm

Particle is nominally a single crystal or consists of only a few crystalline grains.

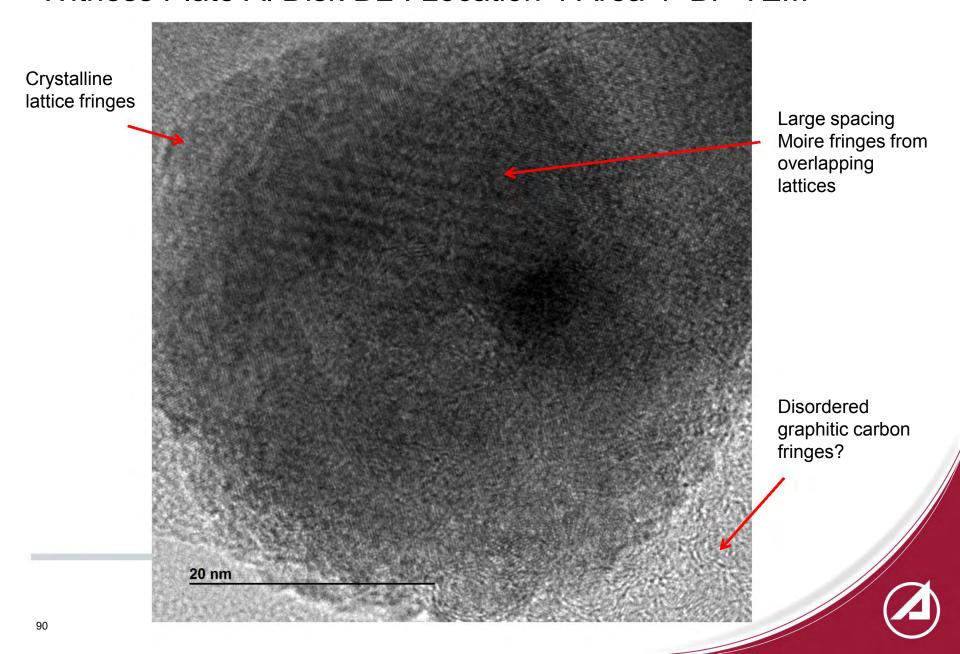


SBU Marking Witness Plate Al Disk D2: Location 4 Area 3 BF-TEM

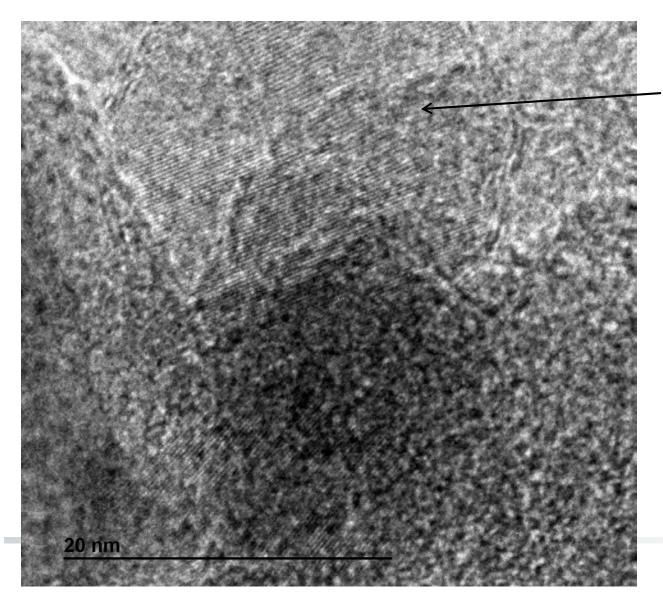


SBU Marking

Witness Plate Al Disk D2: Location 4 Area 4 BF-TEM



Witness Plate Post Test: Al Plate D2: Area 4 BF-TEM

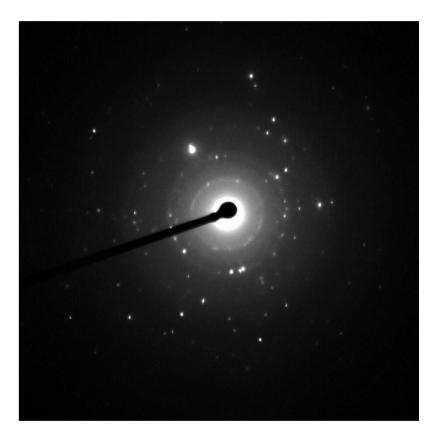


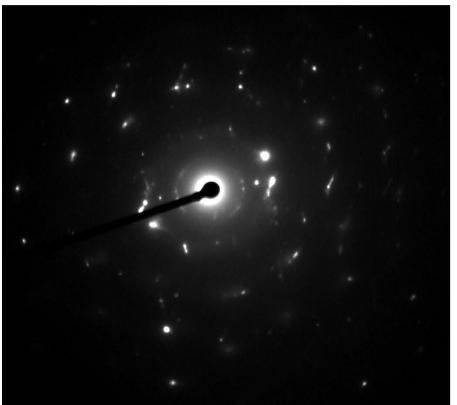
Crystalline lattice fringes

Particle is nominally a single crystal



SBU Marking Witness Plate Al Disk D2: Location 5 TEM Electron Diffraction





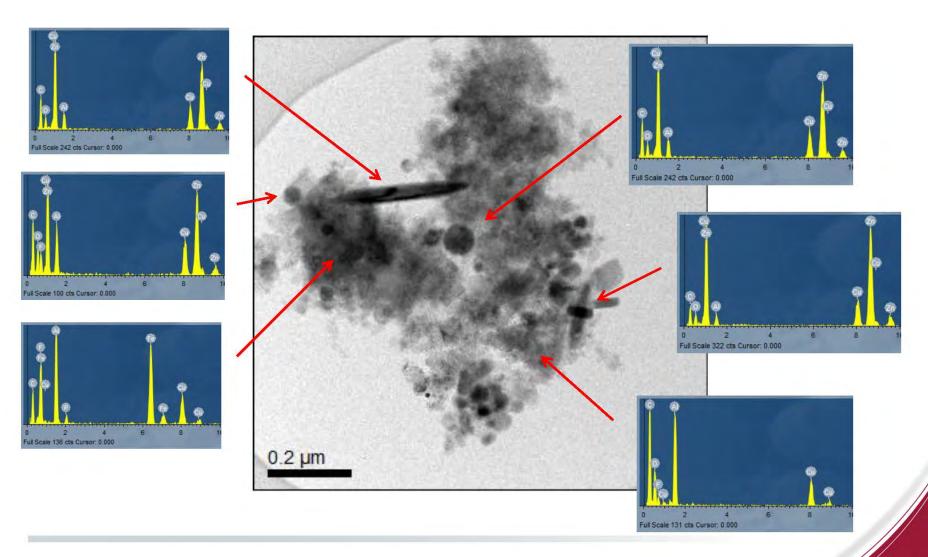
Spot patterns indicate crystallinity

Patterns cover about 0.7 micron diameter area



SBU Marking

Witness Plate Al Disk D2: Location 4 TEM-EDS

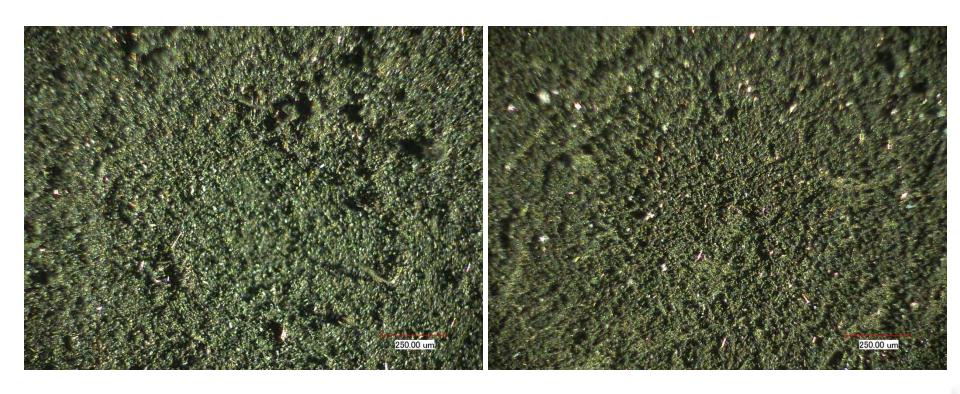


Discreet crystalline particles contain Zn. Al and Fe also detected. Cu is probably from X-rays scattered from the microscope pole piece.



Witness Plate Post Test : Aluminum Disks

(Optical Images – 150X)

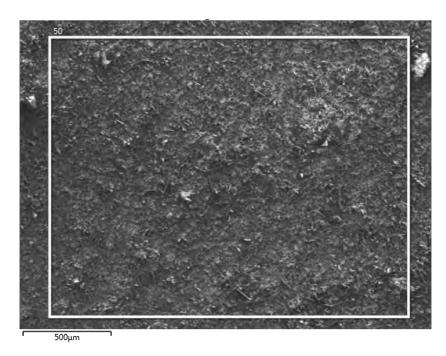


Exposed (B2)

Protected (D2)



Witness Plate Post Test: Aluminum Disk B2 (exposed) SEM EDS Average Composition (10KV)



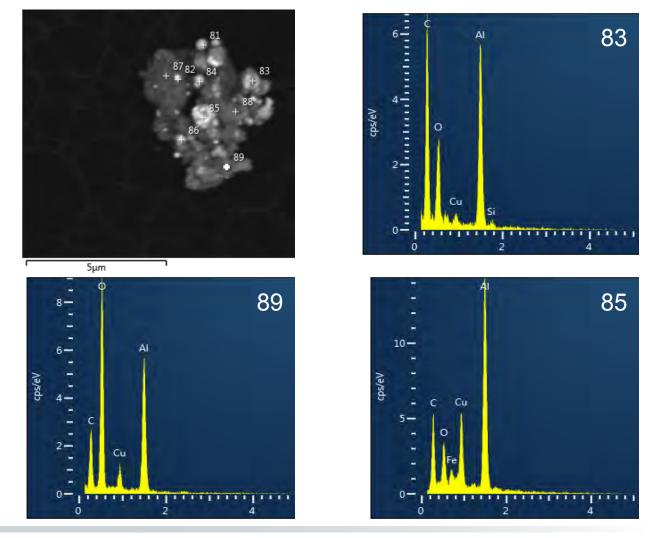
Elemental abundances are similar to SEM stub witness plates on soft catch panels.

	Atomic %	Atomic %
С	63.67	64.82
0	15.89	15.58
F	1.22	1.61
Na	0.00	0.00
Mg	0.22	0.27
Al	13.74	12.72
Si	0.46	0.43
Р	0.34	0.41
S	0.07	0.06
Ca	0.00	0.00
Cr	0.34	0.35
Fe	1.51	1.29
Cu	2.11	1.83
Zn	0.00	0.00
Ge	0.37	0.47
Ag	0.08	0.11
Sn	0.00	0.07
Total	100.00	100.00



Witness Plate Post Test: Aluminum Disk B2 (exposed)

SEM Images of particles suspended on lacey carbon films on Cu TEM grid

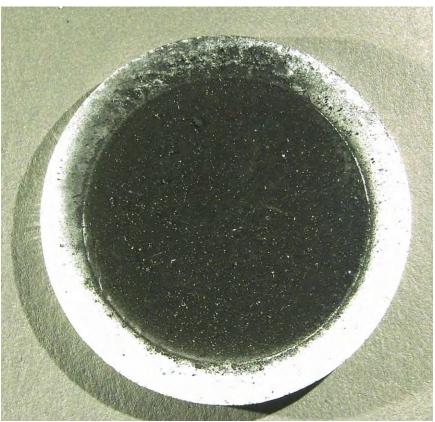


Al, C and O the are most common constituents, also minor Cu.



Witness Plate Post Test: Z93 Painted Aluminum Disks

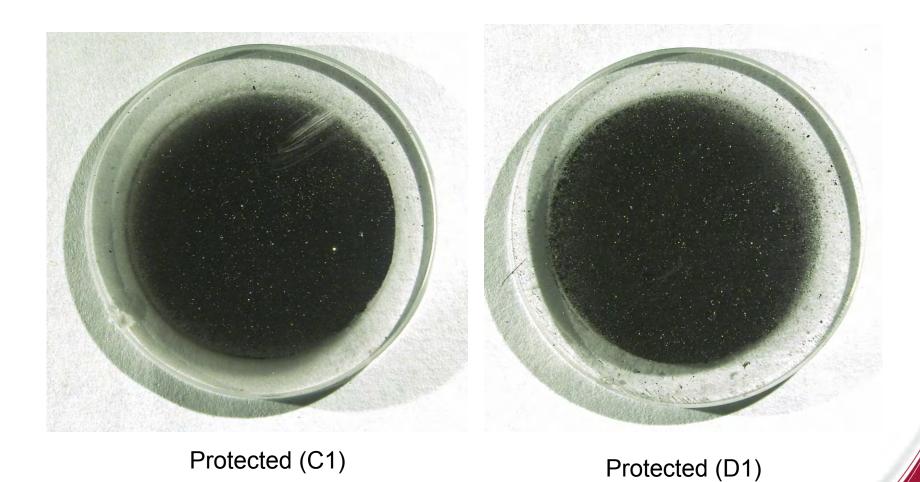




Exposed Protected



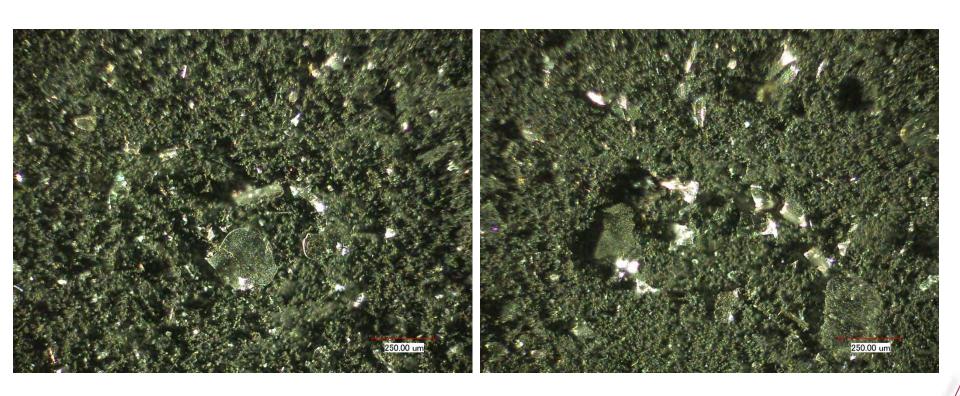
Witness Plate Post Test: Fused Silica Disks



The directly exposed disks were destroyed



Witness Plate Post Test: Fused Silica Disks – Optical Images (150X)



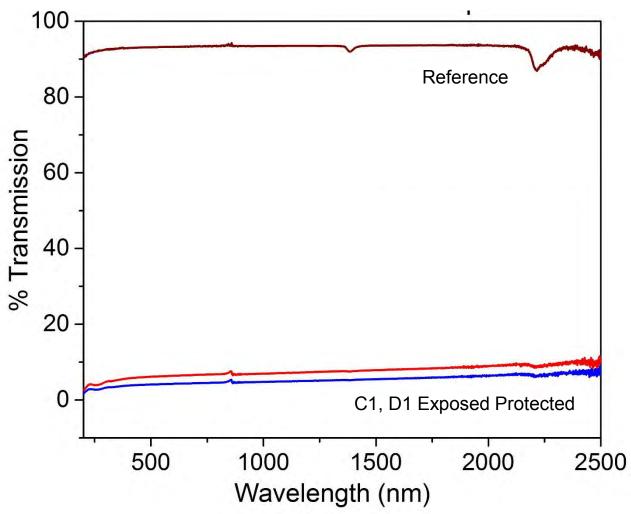
Protected (C1)

Protected (D1)



Witness Plate Fused Silica Disks

UV-VIS-NIR Transmission



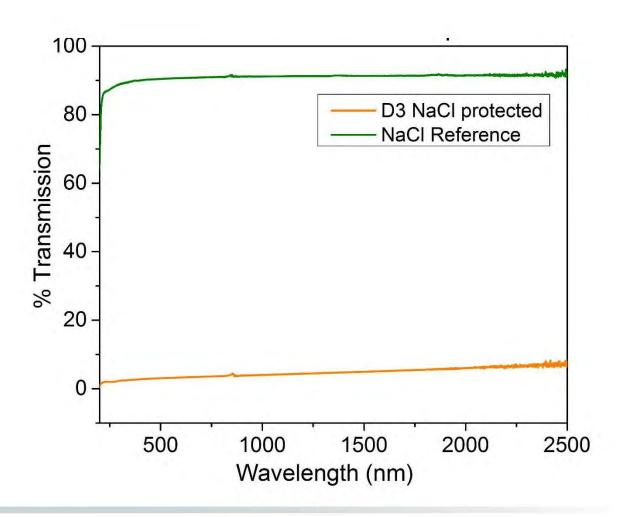




SBU Marking

Witness Plate NaCl Disk

UV-VIS-NIR Transmission



Significant decrease in transmission from 90% to 12%.



Appendix 2



SBU Marking

Technical Reports Addendum Asset Summary



JO: 850672

TRAAS ID #: 2015011406454314820

Report Name: DebriSat Laboratory Analyses

Aerospace Report Number: TOR-2014-00876

Start Date of Test: 2014-05-01

Created By: 14820 Adams, Paul M

End Date of Test: 2014-12-31

First Aerospace Author / PI: 14820 Adams, Paul M

Program: DebriSat

Description: Keywords:

Manufacturer:	PERKIN ELMER CORPORATION	Model:	LAMBDA 900	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Calibration Due D	Date: Comment:		Certificate Num	ber:					
2014-08-17	TMT-NORMAL		fa6f32f7eed80b4	68d87b46e4dfec1aa					
2016-03-13	TMT-NORMAL	777773c04920e64b8f107f76514d6a40							
Manufacturer:	PERKIN ELMER CORPORATION	Model:	PELA-1000	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Calibration Due D	Date: Comment:	Certificate Number:							
2016-04-17	TMT-NORMAL	ed846df747a19149bb42006784ea95a7							
Manufacturer:	RENISHAW	Model:	INVIA	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Calibration Due D	Date: Comment:	Certificate Number:							
2014-07-13	TMT-NORMAL	fd9ec878f3a7f246a89e074b2d36e529							
2200-01-01	SAE	e6467a74b10adc47b9ae2e6d00f01835							
2015-12-13	TAST MODALAT		-MAN-4-0-25004	2-26670165307550					
	Calibration Due D 2014-08-17 2016-03-13 Manufacturer: Calibration Due D 2016-04-17 Manufacturer: Calibration Due D 2014-07-13 2200-01-01	CORPORATION	Manufacturer: CORPORATION Model: Calibration Due Date: Comment: 2014-08-17 TMT-NORMAL Manufacturer: PERKIN ELMER CORPORATION Calibration Due Date: Comment: 2016-04-17 TMT-NORMAL Manufacturer: RENISHAW Model: Calibration Due Date: Comment: 2014-07-13 TMT-NORMAL 2200-01-01 SAE	Manufacturer: CORPORATION Model: LAMBDA 900	Manufacturer: CORPORATION Model: LAMBDA 900 Usage Start Date: 2014-08-17 Comment: Certificate Number: 2014-08-17 TMT-NORMAL fa6f32f7eed80b468d87b46e4dfec1aa 777773c04920e64b8f107f76514d6a40 777773c04920e64b8f107f76514d6a40 Manufacturer: PERKIN ELMER CORPORATION Model: PELA-1000 Usage Start Date: Calibration Due Date: Comment: Certificate Number: 2016-04-17 TMT-NORMAL ed846df747a19149bb42006784ea95a7 Manufacturer: RENISHAW Model: INVIA Usage Start Date: Calibration Due Date: Comment: Certificate Number: 2014-07-13 TMT-NORMAL fid9ec878f3a7f246a89e074b2d36e529 2200-01-01 SAE e6467a74b10adc47b9ae2e6d00f01835	Calibration Due Date: Comment: Certificate Number: 2014-05-01	Manufacturer: CORPORATION Model: LAMBDA 900 Usage Start Date: 2014-05-01 Usage End Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Comment: TMT-NORMAL 777773c04920e64b8f107f6514d6a40 777773c04920e64b8f107f6514d6a40 2014-05-01 Usage End Date: Calibration Due Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Calibration Due Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Calibration Due Date: Comment: Certificate Number: 2014-05-01 Usage End Date: Calibration Due Date: Comment: Certificate Number: 2014-07-13 TMT-NORMAL figes3785a7f246a89e074b2d36e529 2014-05-01 SAE e6467a74b10adc47b9ae2e6d00f01835 2014-05-01 Usage End Date: 2014-07-13 Certificate Number: 2	Manufacturer: CORPORATION	Manufacturer: CORPORATION Model: LAMBDA 900 Usage Start Date: 2014-05-01 Usage End Date: 2014-12-31 Asset Comment:

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SBU Marking

Asset: ABN670	Manufacturer:	JEOL (USA) INC.	Model:	JEM3100F	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Date:	Calibration Due I	Date: Comment:		Certificate Nu	mber:					
2013-01-09 2014-05-08	2014-05-04 2015-12-06	TMT-NORMAL TMT-NORMAL			864aba20d3b3e6d5eb0a b42901343965adb1738					
Asset: ABW501	Manufacturer:	THERMO-NICOLET	Model:	6700	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Date:	Calibration Due I	Date: Comment:		Certificate Nu	mber:					
2014-03-17	2015-08-16	TMT-NORMAL		c0ad25e310e49	9243ae8a043b67c2c0f1					
Asset: ACR364	Manufacturer:	JEOL (USA) INC.	Model:	JSM-7600F	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Date:	Calibration Due I	Date: Comment:		Certificate Nu	mber:					
2014-02-05	2015-07-05	TMT-NORMAL		d498d9360ad1224f85d04309c6869674						
Asset: ACR429	Manufacturer:	OXFORD INSTRUMENTS	Model:	X-MAX	Usage Start Date:	2014-05-01	Usage End Date:	2014-12-31	Asset Comment:	
Date:	Calibration Due I	Date: Comment:		Certificate Number:						
2013-02-08	2014-06-08	TMT-NORMAL		106f65ed9dfc8	043869a5da06587e7fa					
2014-06-02	2015-12-27	TMT-NORMAL		f840182f4f92e	2449d541c92c3465ec2					

^{*}Support and Auxiliary Equipment are not calibrated.

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DebriSat Laboratory Analyses

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